

LMX2430/LMX2433/LMX2434

PLLatinum™ Dual High Frequency Synthesizer for RF

Personal Communications

LMX2430 3.0 GHz/0.8 GHz

LMX2433 3.6 GHz/1.7 GHz LMX2434 5.0 GHz/2.5 GHz

General Description

The LMX243x devices are high performance frequency synthesizers with integrated dual modulus prescalers. The LMX243x devices are designed for use as RF and IF local oscillators for dual conversion radio transceivers.

A 32/33 or a 16/17 prescale ratio can be selected for the 5.0 GHz LMX2434 RF synthesizer. An 8/9 or a 16/17 prescale ratio can be selected for both the LMX2430 and LMX2433 RF synthesizers. The IF circuitry contains an 8/9 or a 16/17 prescaler. Using a proprietary digital phase locked loop technique, the LMX243x devices generate very stable, low noise control signals for RF and IF voltage controlled oscillators. Both the RF and IF synthesizers include a two-level programmable charge pump. Both the RF and IF synthesizers have dedicated Fastlock circuitry with integrated timeout counters. Furthermore, only a single word write is required to power up and tune the synthesizers to a new frequency.

Serial data is transferred to the devices via a three-wire interface (DATA, LE, CLK). A low voltage logic interface allows direct connection to 1.8V devices. Supply voltages from 2.25V to 2.75V are supported. The LMX243x family features low current consumption:

LMX2430 (3.0 GHz/ 0.8 GHz) — 2.8 mA/ 1.4 mA, LMX2433 (3.6 GHz/ 1.7 GHz) — 3.2 mA/ 2.0 mA, LMX2434 (5.0 GHz/ 2.5 GHz) — 4.6 mA/ 2.4 mA at 2.50V.

The LMX243x devices are available in 20-Pin TSSOP and 20-Pin UTCSP surface mount plastic packages.

Features

- Low Current Consumption
- 2.25V to 2.75V Operation
- Selectable Synchronous or Asynchronous Powerdown Mode
- Selectable Dual Modulus Prescaler:

LMX2430 RF: 8/9 or 16/17 LMX2433 RF: 8/9 or 16/17 LMX2434 RF: 16/17 or 32/33 LMX243x IF: 8/9 or 16/17

- Programmable Charge Pump Current Levels RF and IF: 1 or 4 mA
- Fastlock[™] Technology with Integrated Timeout Counters
- Digital Filtered Lock Detect Output
- Analog Lock Detect Output (supports both Push-Pull and Open Drain configurations)
- 1.8V MICROWIRE Logic Interface
- Available in 20-Pin TSSOP and 20-Pin UTCSP

Applications

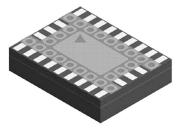
- Mobile Handsets (GSM, GPRS, W-CDMA, CDMA, PCS, AMPS, PDC, DCS)
- Cordless Handsets (DECT, DCT)
- Wireless Data
- Cable TV Tuners

Thin Shrink Small Outline Package (MTC20)



20053580

Ultra Thin Chip Scale Package (SLE20A)



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Functional Block Diagram 8 (9) 16 (17) 20 (1) Vcc Vcc Vcc ← FLoutIF/OSCout 6 (7) MUX FASTLOCK 2 (3) FinIF 18-BIT IF N COUNTER IF PRESCALER PHASE CHARGE ▶**♦** CPoutIF 4 (5) DETECTOR PUMP IF 15-BIT IF LOCK DETECT R COUNTER MUX ▶**♦** Ftest/LD 9 (10) 7 (8) OSCin RF LOCK DETECT 15-BIT RF R COUNTER CHARGE PUMP PHASE 19-BIT RF N COUNTER **→** CPoutRF 12 (13) 14 (15) FinRF RF PRESCALER DETECTOR 15 (16) FinRF* FLoutRF 10 (11) 19 (20) CLK 0 18 (19) DATA 0 17 (18) LE 0 3 (4) EN 0 5 (6) ENosc 0 FASTLOCK MICROWIRE INTERFACE LMX2430/LMX2433/LMX2434 GND 1 (2) GND GND 11 (12) 13 (14)

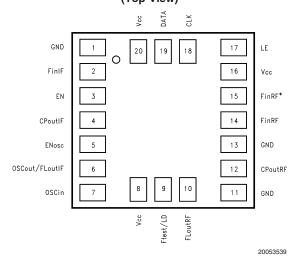
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Note:

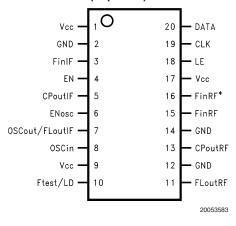
1 (2) refers to Pin #1 of the 20-Pin UTCSP and Pin #2 of the 20-Pin TSSOP

Connection Diagrams

Ultra Thin Chip Scale Package (SLE) (Top View)



Thin Shrink Small Outline Package (TM) (Top View)



Pin Descriptions

Pin No. UTCSP	Pin No. TSSOP	Pin Name	I/O	Description
1	2	GND	_	Ground for the IF PLL analog and digital circuits, MICROWIRE TM , Ftest/LD and oscillator circuits.
2	3	FinIF	I	IF PLL prescaler input. Small signal input from the VCO.
3	4	EN	_	Chip Enable input. High Impedance CMOS input. When this pin is set HIGH, the RF and IF PLLs are powered up. Powerdown is then controlled through the MICROWIRE. When this pin is set LOW, the device is asynchronously powered down and the charge pump output is forced to a high impedance state (TRI-STATE).
4	5	CPoutIF	0	IF PLL charge pump output. The output is connected to the external loop filter, which drives the input of the IF VCO.
5	6	ENosc	I	Oscillator Enable input. High impedance CMOS input. When this pin is set HIGH, the oscillator buffer is always powered up, independent of the state of the EN pin. When this pin is set LOW, the OSCout/ FLoutIF pin functions as an IF Fastlock output, which connects a resistor in parallel to R2 of the external loop filter.
6	7	OSCout/ FLoutIF	0	Oscillator output/ IF PLL Fastlock output. The output configuration is dependent on the state of the ENosc pin. When ENosc is set LOW, the pin functions as an IF Fastlock output, which connects a resistor in parallel to R2 of the external loop filter. This configuration also functions as a general purpose CMOS TRI-STATE output. When ENosc is set HIGH, the pin functions as an oscillator output so that an external crystal can be used.
7	8	OSCin	I	Reference oscillator input. The input has an approximate Vcc/2 threshold and is driven by an external AC coupled source.
8	9	Vcc		Power supply bias for the RF PLL digital circuits and oscillator circuits. Vcc may range from 2.25V to 2.75V. Bypass capacitors should be placed as close as possible to this pin and be connected directly to the ground plane.
9	10	Ftest/LD	0	Programmable multiplexed output. Functions as a general purpose CMOS TRI-STATE output, N and R divider output, RF/ IF PLL push-pull analog lock detect output, RF/ IF PLL open-drain analog lock detect output, or RF/ IF PLL digital filtered lock detect output.

Pin Descriptions (Continued)

Pin No. UTCSP	Pin No. TSSOP	Pin Name	I/O	Description
10	11	FLoutRF	0	RF PLL Fastlock output. This pin connects a resistor in parallel to R2 of the external loop filter. This pin can also function as a general purpose CMOS TRI-STATE output.
11	12	GND	1	Ground for the RF PLL digital circuits.
12	13	CPoutRF	0	RF PLL charge pump output. The output is connected to the external loop filter, which drives the input of the RF VCO.
13	14	GND		Ground for the RF PLL analog circuits.
14	15	FinRF	I	RF PLL prescaler input. Small signal input from the VCO.
15	16	FinRF*	l	RF PLL prescaler complementary input. For single ended operation, this pin should be AC grounded through a 100 pF capacitor. The LMX243x can be driven differentially when the AC coupled capacitor is omitted.
16	17	Vcc	-	Power supply bias for the RF PLL analog circuits. Vcc may range from 2.25V to 2.75V. Bypass capacitors should be placed as close as possible to this pin and be connected directly to the ground plane.
17	18	LE	I	MICROWIRE Latch Enable input. High impedance CMOS input. When LE transitions HIGH, DATA stored in the shift register is loaded into one of 6 internal control registers.
18	19	CLK	I	MICROWIRE Clock input. High impedance CMOS input. DATA is clocked into the 24-bit shift register on the rising edge of CLK.
19	20	DATA	Ι	MICROWIRE Data input. High impedance CMOS input. Binary serial data. The MSB of DATA is shifted in first. The two last bits are the control bits.
20	1	Vcc	_	Power supply bias for the IF PLL analog and digital circuits, MICROWIRE, and Ftest/LD circuits. Vcc may range from 2.25V to 2.75V. Bypass capacitors should be placed as close as possible to this pin and be connected directly to the ground plane

Ordering Information

Model	Temperature Range	Package Description	Packing	NS Package Number
LMX2430TM	-40°C to +85°C	Thin Shrink Small	73 Units Per Rail	MTC20
		Outline Package		
		(TSSOP)		
LMX2430TMX	-40°C to +85°C	Thin Shrink Small	2500 Units Per Reel	MTC20
		Outline Package		
		(TSSOP)		
		Tape and Reel		
LMX2430SLEX	-40°C to +85°C	Ultra Thin Chip Scale	2500 Units Per Reel	SLE20A
		Package (UTCSP)		
		Tape and Reel		
LMX2433TM	-40°C to +85°C	Thin Shrink Small	73 Units Per Rail	MTC20
		Outline Package		
		(TSSOP)		
LMX2433TMX	-40°C to +85°C	Thin Shrink Small	2500 Units Per Reel	MTC20
		Outline Package		
		(TSSOP)		
		Tape and Reel		
LMX2433SLEX	-40°C to +85°C	Ultra Thin Chip Scale	2500 Units Per Reel	SLE20A
		Package (UTCSP)		
		Tape and Reel		
LMX2434TM	-40°C to +85°C	Thin Shrink Small	73 Units Per Rail	MTC20
		Outline Package		
		(TSSOP)		
LMX2434TMX	-40°C to +85°C	Thin Shrink Small	2500 Units Per Reel	MTC20
		Outline Package		
		(TSSOP)		
		Tape and Reel		
LMX2434SLEX	-40°C to +85°C	Ultra Thin Chip Scale	2500 Units Per Reel	SLE20A
		Package (UTCSP)		
		Tape and Reel		

Absolute Maximum Ratings (Notes 1,

2, 3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Power Supply Voltage

Vcc to GND -0.3V to +3.25V

Voltage on any pin to GND (V_I)

 Recommended Operating Conditions (Note 1)

Power Supply Voltage

Vcc to GND +2.25V to +2.75V Operating Temperature (T_A) -40°C to +85°C

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Recommended Operating Conditions indicate conditions for which the device is intended to be functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, refer to the Electrical Characteristics section. The guaranteed specifications apply only for the conditions listed.

Note 2: This device is a high performance RF integrated circuit with an ESD rating <2 kV and is ESD sensitive. Handling and assembly of this device should only be done at ESD protected work stations.

Note 3: GND = 0V

Electrical Characteristics

 $\mbox{Vcc} = \mbox{EN} = 2.5 \mbox{V}, \ -40 \mbox{°C} \leq \mbox{T}_{\mbox{A}} \leq +85 \mbox{°C}, \ \mbox{unless otherwise specified}$

Symbol	Por	ameter	Conditions		Value		Units
Symbol			Conditions	Min	Тур	Max	Units
I _{CC} PARAM	IETERS			•			
Icc _{RF}	Power Supply Current, RF	LMX2430	CLK, DATA and LE = 0V OSCin = GND		2.8	3.6	mA
	Synthesizer	LMX2433	RF_PD Bit = 0		3.2	4.4	mA
		LMX2434	IF_PD Bit = 1 RF_P Bit = 0		4.6	6.2	mA
Icc _{IF}	Power Supply Current, IF	LMX2430	CLK, DATA and LE = 0V OSCin = GND		1.4	2.0	mA
	Synthesizer	LMX2433	RF_PD Bit = 1		2.0	2.8	mA
		LMX2434	IF_PD Bit = 0 IF_P Bit = 0		2.4	3.5	mA
Icc _{PD}	Powerdown Curre	nt	EN, ENosc, CLK, DATA and LE = 0V			10	μА
RF SYNTHI	ESIZER PARAMETE	RS			•		
f _{FinRF}	RF Operating	LMX2430	RF_P Bit = 0	250		2500	MHz
	Frequency		RF_P Bit = 1	250		3000	MHz
		LMX2433	RF_P Bit = 0	500		3000	MHz
			RF_P Bit = 1	500		3600	MHz
		LMX2434	RF_P Bit = 0 or 1	1000		5000	MHz
N_{RF}	N Divider Range	'	P = 8/9 (Note 4)	24		262151	
			P = 16/17 (Note 4)	48		524287	
			P = 32/33 (Note 4)	96		524287	
R _{RF}	RF R Divider Rang	ge	,	3		32767	\vdash
f _{COMPRF}	RF Phase Detecto	_				10	MHz
p _{FinRF}	RF Input Sensitivit	<u> </u>	LMX2430/33 2.25V ≤ Vcc ≤ 2.75V	-15		0	dBm
			(Note 5) LMX2434	-12		0	dBm
			2.35V ≤ Vcc ≤ 2.75V	-12			uBin
			(Note 5)				

Electrical Characteristics (Continued) Vcc = EN = 2.5V, -40° C \leq T_A \leq +85 $^{\circ}$ C, unless otherwise specified

0	Parameter		0		Value		
Symbol	Parame	ter	Conditions	Min	Тур	Max	Units
RF SYNTHE	SIZER PARAMETERS			•		•	•
I _{CPoutRF} Source	RF Charge Pump Out Current	put Source	V _{CPoutRF} = Vcc/2 RF_CPG Bit = 0 (Note 6)		-1.0		mA
			V _{CPoutRF} = Vcc/2 RF_CPG Bit = 1 (Note 6)		-4.0		mA
I _{CPoutRF} Sink	RF Charge Pump Out	put Sink Current	V _{CPoutRF} = Vcc/2 RF_CPG Bit = 0 (Note 6)		1.0		mA
			V _{CPoutRF} = Vcc/2 RF_CPG Bit = 1 (Note 6)		4.0		mA
I _{CPoutRF} TRI	RF Charge Pump Out Current	put TRI-STATE	$0.5V \le V_{CPoutRF} \le Vcc - 0.5V$ (Note 6)	-2.5		2.5	nA
I _{CPoutRF} %MIS	RF Charge Pump Out Vs Charge Pump Out Current Mismatch		V _{CPoutRF} = Vcc/2 (Note 7)		3	10	%
I _{CPoutRF} %V _{CPoutRF}	RF Charge Pump Out Magnitude Variation V Output Voltage		$0.5V \le V_{CPoutRF} \le Vcc - 0.5V$ (Note 7)		5	15	%
I _{CPoutRF} %T _A	RF Charge Pump Out Magnitude Variation V		V _{CPoutRF} = Vcc/2 (Note 7)		2		%
IF SYNTHES	SIZER PARAMETERS						_
f_{FinIF}	IF Operating	LMX2430	IF_P Bit = 0 or 1	100		800	MHz
	Frequency	LMX2433	IF_P Bit = 0 or 1	250		1700	MHz
		LMX2434	IF_P Bit = 0 or 1	500		2500	MHz
N_{IF}	IF N Divider Range		P = 8/9 (Note 4)	24		131079	
			P = 16/17 (Note 4)	48		262143	
R _{IF}	IF R Divider Range			3		32767	
f _{COMPIF}	IF Phase Detector Fre	quency				10	MHz
P _{FinIF}	IF Input Sensitivity		2.25V ≤ Vcc ≤ 2.75V (Note 5)	-15		0	dBm
I _{CPoutIF} Source	IF Charge Pump Outp Current	ut Source	V _{CPoutIF} = Vcc/2 IF_CPG Bit = 0 (Note 6)		-1.0		mA
			V _{CPoutIF} = Vcc/2 IF_CPG Bit = 1 (Note 6)		-4.0		mA
I _{CPoutIF} Sink	IF Charge Pump Outp	ut Sink Current	V _{CPoutIF} = Vcc/2 IF_CPG Bit = 0 (Note 6)		1.0		mA
			V _{CPoutIF} = Vcc/2 IF_CPG Bit = 1 (Note 6)		4.0		mA

Symbol IF SYNTHE I _{CPoutIF} TRI	Parameter	Conditions		Value		Units
Syllibol	Parameter	Conditions	Min	Тур	Max	
IF SYNTHE	SIZER PARAMETERS					
I _{CPoutIF}	IF Charge Pump Output TRI-STATE	$0.5V \le V_{CPoutlF} \le Vcc - 0.5V$	-2.5		2.5	nA
TRI	Current	(Note 6)				
I _{CPoutIF}	IF Charge Pump Output Sink Current	V _{CPoutIF} = Vcc/2		3	10	%
%MIS	Vs Charge Pump Output Source	(Note 7)				
	Current Mismatch					
I _{CPoutIF}	IF Charge Pump Output Current	$0.5V \le V_{CPoutlF} \le Vcc - 0.5V$		5	15	%
$%V_{CPoutIF}$	Magnitude Variation Vs Charge Pump	(Note 7)				
	Output Voltage					
$I_{CPoutIF}$	IF Charge Pump Output Current	V _{CPoutIF} = Vcc/2		2		%
%T _A	Magnitude Variation Vs Temperature	(Note 7)				
OSCILLATO	OR PARAMETERS					
f _{OSCin}	Oscillator Operating Frequency		1		256	MHz
V _{OSCin}	Oscillator Sensitivity	(Note 8)	0.5		Vcc	V _{PP}
I _{OSCin}	Oscillator Input Current	V _{OSCin} = Vcc			100	μΑ
		V _{OSCin} = 0V	-100			μΑ
DIGITAL IN	TERFACE (DATA, CLK, LE, EN, ENosc	, Ftest/LD, FLoutRF, OSCout/ FL	outIF)			·
V _{IH}	High-Level Input Voltage		1.6			V
V _{IL}	Low-Level Input Voltage				0.4	V
I _{IH}	High-Level Input Current	V _{IH} = Vcc			1.0	μΑ
I _{IL}	Low-Level Input Current	$V_{IL} = 0V$	-1.0			μΑ
V _{OH}	High-Level Output Voltage	I _{OH} = -500 μA	V _{CC} -			V
			0.4			
V _{OL}	Low-Level Output Voltage	I _{OL} = 500 μA			0.4	V
MICROWIR	E INTERFACE					
t _{cs}	DATA to CLK Set Up Time	(Note 9)	50			ns
t _{CH}	DATA to CLK Hold Time	(Note 9)	10			ns
t _{CWH}	CLK Pulse Width HIGH	(Note 9)	50			ns
t _{CWL}	CLK Pulse Width LOW	(Note 9)	50			ns
t _{ES}	CLK to LE Set Up Time	(Note 9)	50			ns
LU	LE Pulse Width	(Note 9)	50		 	ns

Electrical Characteristics (Continued)

 $Vcc = EN = 2.5V, -40^{\circ}C \le T_A \le +85^{\circ}C$, unless otherwise specified

Symbol	Parame	tor	Conditions		Value		Units
	Parame	tei	Conditions	Min	Тур	Max	Ullits
PHASE NOI	SE CHARACTERISTIC	S					
L _{NRF} (f)	RF Synthesizer Norma Noise Contribution (Note 10)	llized Phase	TCXO Reference Source RF_CPG Bit = 1 IF_PD Bit = 1		-219.0		dBc/ Hz
L _{NIF} (f)	IF Synthesizer Normal Noise Contribution (Note 10)	ized Phase	TCXO Reference Source IF_CPG Bit = 1 RF_PD Bit = 1		-214.0		dBc/ Hz
L _{RF} (f)	RF Synthesizer Single Side Band Phase Noise Measured	LMX2430	$f_{\text{FinRF}} = 2750 \text{ MHz}$ $f = 10 \text{ kHz offset}$ $f_{\text{COMPRF}} = 1 \text{ MHz}$ $\text{Loop Bandwidth} = 100 \text{ kHz}$ $N_{\text{RF}} = 2750$ $f_{\text{OSCin}} = 10 \text{ MHz}$ $v_{\text{OSCin}} = 1 \text{ V}_{\text{PP}}$ $\text{RF_CPG Bit} = 1$ $\text{IF_PD Bit} = 1$ $T_{\text{A}} = +25^{\circ}\text{C}$ (Note 11)		-90.30		dBc/ Hz
		LMX2433	$\begin{split} f_{\text{FinRF}} &= 3200 \text{ MHz} \\ f &= 10 \text{ kHz offset} \\ f_{\text{COMPRF}} &= 1 \text{ MHz} \\ \text{Loop Bandwidth} &= 100 \text{ kHz} \\ N_{\text{RF}} &= 3200 \\ f_{\text{OSCin}} &= 10 \text{ MHz} \\ v_{\text{OSCin}} &= 1 \text{ V}_{\text{PP}} \\ \text{RF_CPG Bit} &= 1 \\ \text{IF_PD Bit} &= 1 \\ T_{\text{A}} &= +25^{\circ}\text{C} \\ \text{(Note 11)} \end{split}$		-88.90		dBc/ Hz
		LMX2434	$\begin{split} f_{\text{FinRF}} &= 4700 \text{ MHz} \\ f &= 10 \text{ kHz offset} \\ f_{\text{COMPRF}} &= 1 \text{ MHz} \\ \text{Loop Bandwidth} &= 100 \text{ kHz} \\ N_{\text{RF}} &= 4700 \\ f_{\text{OSCin}} &= 10 \text{ MHz} \\ v_{\text{OSCin}} &= 1 \text{ V}_{\text{PP}} \\ \text{RF_CPG Bit} &= 1 \\ \text{IF_PD Bit} &= 1 \\ T_{\text{A}} &= +25^{\circ}\text{C} \\ \text{(Note 11)} \end{split}$		-85.60		dBc/ Hz

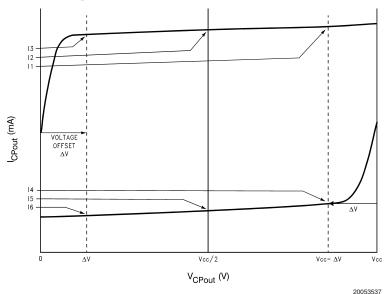
Note 4: Some of the values in this range are illegal divide ratios (B < A). To obtain continuous legal division, the Minimum Divide Ratio must be calculated. Use N \geq P * (P-1), where P is the value of the prescaler selected.

- Note 5: Refer to the LMX243x FinRF Sensitivity Test Setup section
- $\textbf{Note 6:} \ \ \text{Refer to the LMX243x Charge Pump Test Setup section}$
- Note 7: Refer to the Charge Pump Current Specification Definitions for details on how these measurements are made.
- Note 8: Refer to the LMX243x OSCin Sensitivity Test Setup section
- Note 9: Refer to the LMX243x Serial Data Input Timing section

Note 10: Normalized Phase Noise Contribution is defined as: $L_N(f) = L(f) - 20 \log (N) - 10 \log (f_{COMP})$, where L(f) is defined as the single side band phase noise measured at an offset frequency, f, in a 1 Hz bandwidth. The offset frequency, f, must be chosen sufficiently smaller than the PLL's loop bandwidth, yet large enough to avoid substantial phase noise contribution from the reference source. N is the value selected for the feedback divider and f_{COMP} is the RF/IF phase/ frequency detector comparison frequency.

Note 11: The synthesizer phase noise is measured with the LMX2430TM/LMX2430SLE Evaluation boards and the HP8566B Spectrum Analyzer.

Charge Pump Current Specification Definitions



I1 = Charge Pump Sink Current at $V_{CPout} = Vcc - \Delta V$

I2 = Charge Pump Sink Current at $V_{CPout} = Vcc//2$

I3 = Charge Pump Sink Current at $V_{CPout} = \Delta V$

I4 = Charge Pump Source Current at $V_{CPout} = Vcc - \Delta V$

I5 = Charge Pump Source Current at V_{CPout} = Vcc/2

I6 = Charge Pump Source Current at $V_{CPout} = \Delta V$

 $\Delta V = Voltage$ offset from the positive and negative rails. Dependent on the VCO tuning range relative to Vcc and GND. Typical values are between 0.5V and 1.0V.

 V_{CPout} refers to either $V_{CPoutRF}$ or $V_{CPoutIF}$

I_{CPout} refers to either I_{CPoutRF} or I_{CPoutIF}

Charge Pump Output Current Magnitude Variation Vs Charge Pump Output Voltage

$$I_{CPout} \ Vs \ V_{CPout} = \frac{(|11| - |13|)}{(|11| + |13|)} \times 100\%$$

$$= \frac{(|14| - |16|)}{(|14| + |16|)} \times 100\%$$

Charge Pump Output Sink Current Vs Charge Pump Output Source Current Mismatch

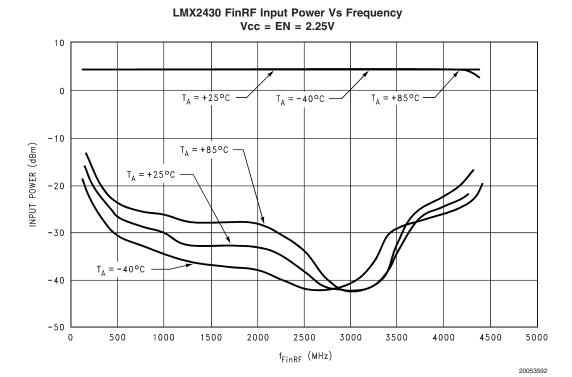
$$I_{CPout}$$
 Sink Vs I_{CPout} Source = $\frac{||2| - ||5|}{\frac{1}{2}(||2| + ||5|)} \times 100\%$

Charge Pump Output Current Magnitude Variation Vs Temperature

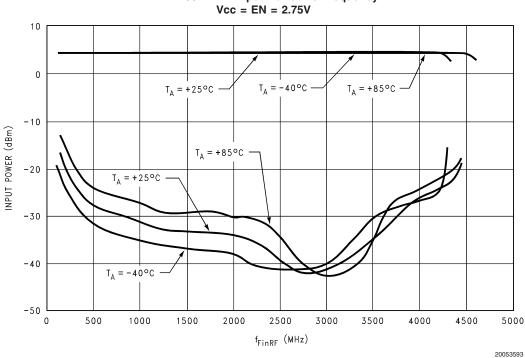
$$I_{CPout} \ Vs \ T_{A} = \frac{|I_{2}| \Big|_{T_{A}} - |I_{2}| \Big|_{T_{A} = 25^{\circ}C}}{|I_{2}| \Big|_{T_{A} = 25^{\circ}C}} \times 100\%$$

$$= \frac{|I_{5}| \Big|_{T_{A}} - |I_{5}| \Big|_{T_{A} = 25^{\circ}C}}{|I_{5}| \Big|_{T_{A} = 25^{\circ}C}} \times 100\%$$

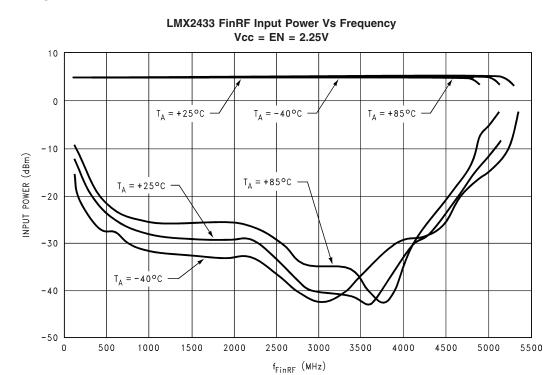
Typical Performance Characteristics Sensitivity



LMX2430 FinRF Input Power Vs Frequency



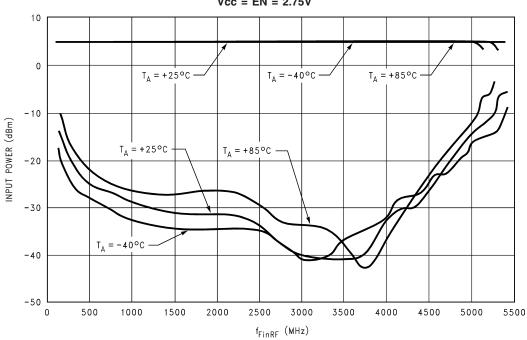
Typical Performance Characteristics Sensitivity (Continued)



LMX2433 FinRF Input Power Vs Frequency Vcc = EN = 2.75V

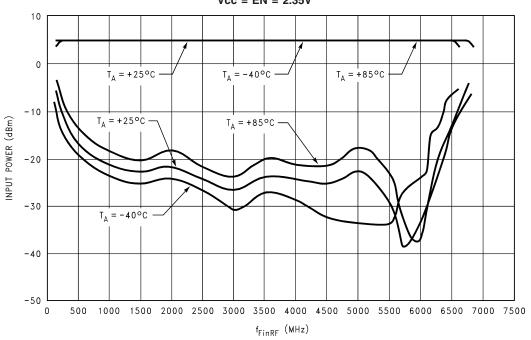
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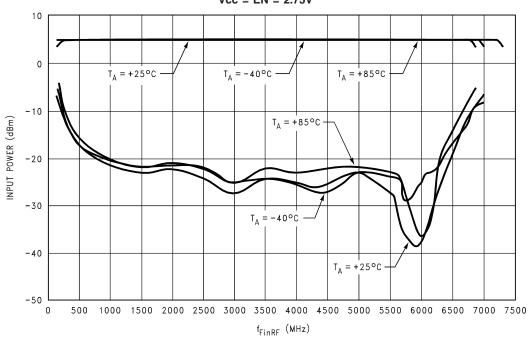
Typical Performance Characteristics Sensitivity (Continued)

LMX2434 FinRF Input Power Vs Frequency Vcc = EN = 2.35V



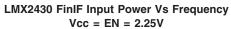
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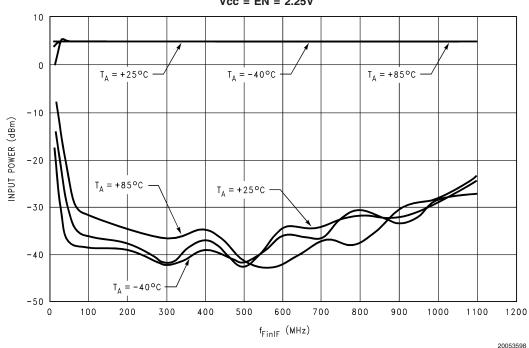
LMX2434 FinRF Input Power Vs Frequency Vcc = EN = 2.75V



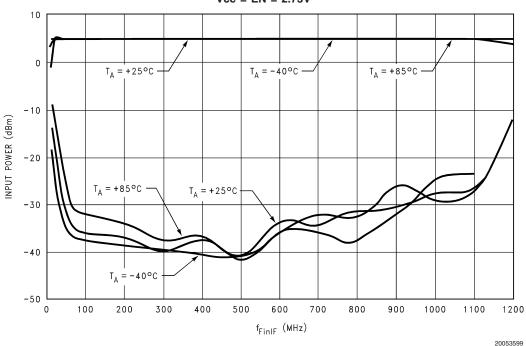
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Typical Performance Characteristics Sensitivity (Continued)

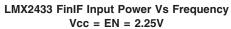


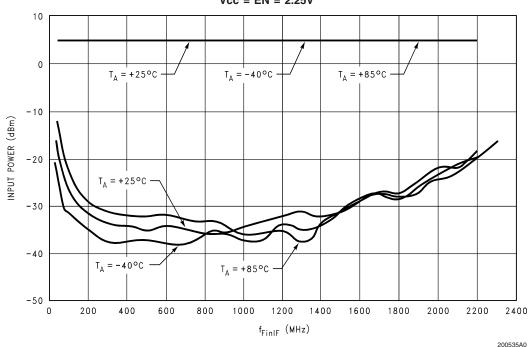


LMX2430 FinIF Input Power Vs Frequency Vcc = EN = 2.75V

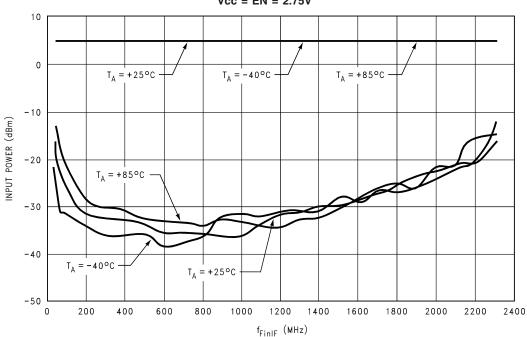


Typical Performance Characteristics Sensitivity (Continued)



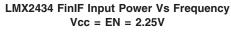


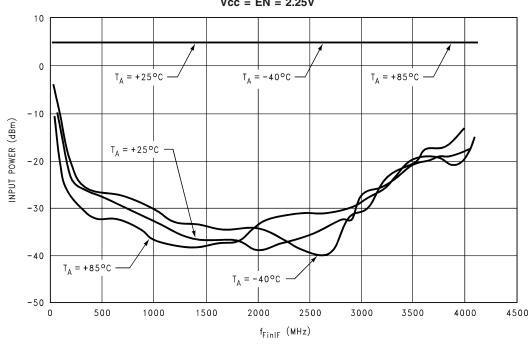
LMX2433 FinIF Input Power Vs Frequency Vcc = EN = 2.75V



200535A1

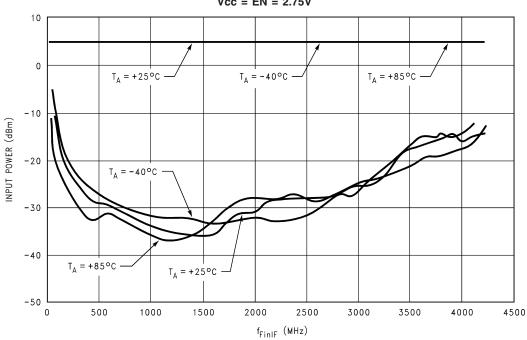
Typical Performance Characteristics Sensitivity (Continued)





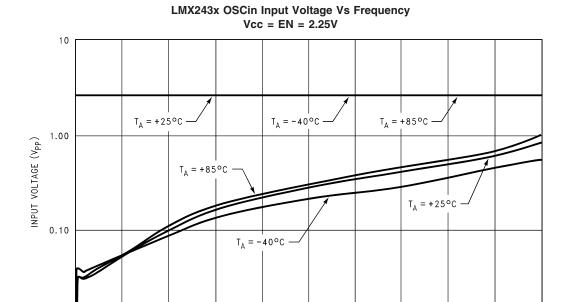
200535A2

LMX2434 FinIF Input Power Vs Frequency Vcc = EN = 2.75V



200535A3

Typical Performance Characteristics Sensitivity (Continued)



200535A4

1000

LMX243x OSCin Input Voltage Vs Frequency Vcc = EN = 2.75V

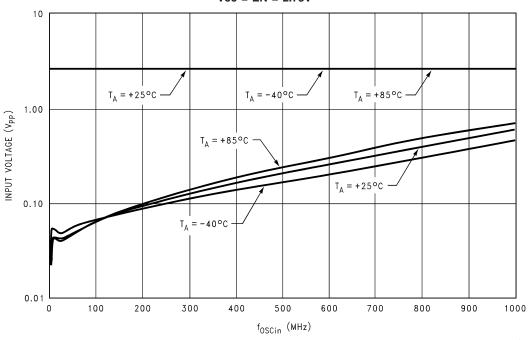
500

f_{OSCin} (MHz)

700

400

300

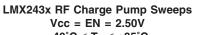


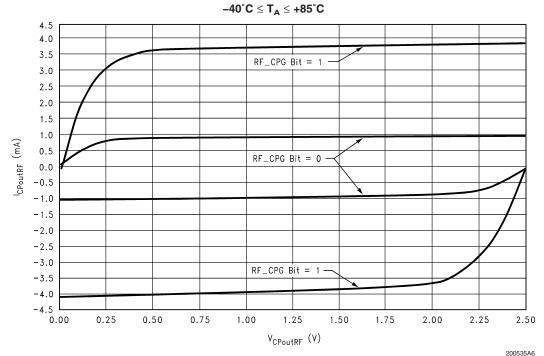
200535A5

0.01

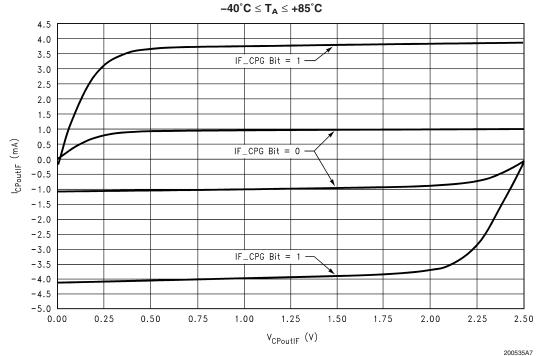
100

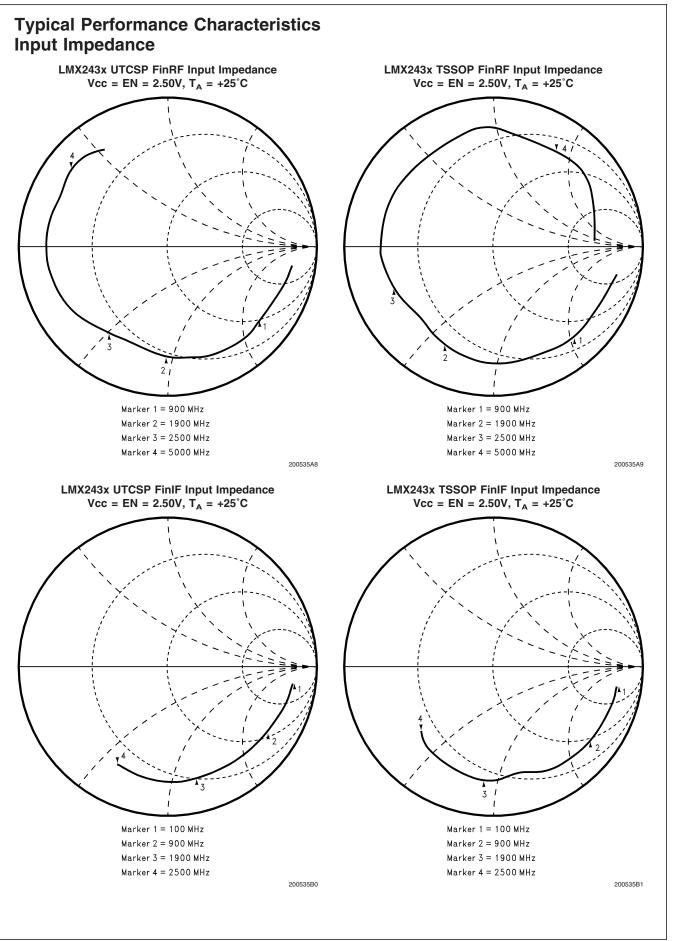
Typical Performance Characteristics Charge Pump



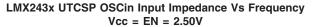


LMX243x IF Charge Pump Sweeps Vcc = EN = 2.50V

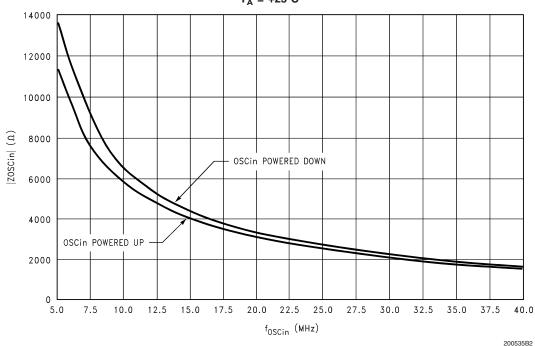




Typical Performance Characteristics Input Impedance (Continued)

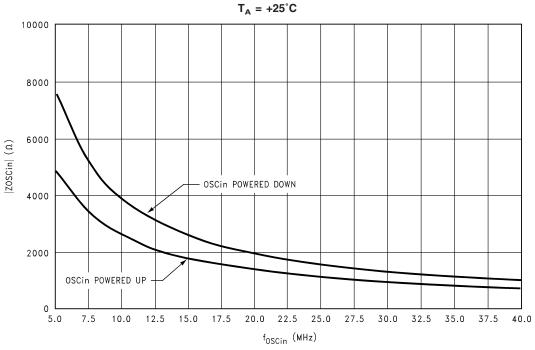






LMX233xU TSSOP OSCin Input Impedance Vs Frequency

Vcc = EN = 2.50V



LMX243x UTCSP FinRF Input Impedance Table Vcc = EN = 2.50V, T_A = +25°C

f _{FinRF} (MHz)	lΓl	Angle (Γ) (°)	Re {ZFinRF} (Ω)	Im {ZFinRF} (Ω)	lZFinRFl (Ω)
100	0.86	-8.63	334.27	-339.55	476.48
200	0.86	-10.72	265.44	-313.48	410.77
300	0.85	-13.48	202.09	-281.42	346.46
400	0.84	-17.01	150.76	-245.31	287.93
500	0.83	-21.05	112.18	-212.85	240.60
600	0.82	-25.32	85.96	-185.41	204.37
700	0.82	-29.78	67.32	-162.49	175.88
800	0.81	-34.35	54.27	-143.15	153.09
900	0.80	-39.02	44.76	-127.07	134.72
1000	0.80	-43.83	37.32	-113.62	119.59
1100	0.79	-48.76	31.65	-102.07	106.86
1200	0.79	-53.90	27.30	-91.89	95.86
1300	0.78	-59.07	23.84	-82.83	86.19
1400	0.78	-64.41	21.34	-74.84	77.82
1500	0.77	-70.04	19.20	-67.56	70.24
1600	0.76	-75.84	17.46	-60.88	63.33
1700	0.75	-82.06	16.27	-54.72	57.09
1800	0.73	-88.56	15.36	-48.89	51.25
1900	0.72	-95.19	14.90	-43.34	45.83
2000	0.70	-101.45	14.32	-38.66	41.23
2100	0.68	-107.85	14.10	-34.26	37.05
2200	0.67	-114.12	13.81	-30.35	33.34
2300	0.66	-120.12	13.27	-27.09	30.17
2400	0.66	-126.01	12.50	-24.00	27.06
2500	0.67	-131.82	11.68	-21.22	24.22
2600	0.69	-137.96	10.55	-18.24	21.07
2700	0.71	-144.21	9.53	-15.58	18.26
2800	0.72	-150.25	8.55	-12.92	15.49
2900	0.74	-156.23	7.75	-10.25	12.85
3000	0.75	-161.92	7.22	-7.77	10.61
3100	0.76	-167.18	6.87	-5.48	8.79
3200	0.77	-172.05	6.63	-3.42	7.46
3300	0.77	-177.55	6.40	-1.49	6.57
3400	0.78	179.16	6.18	0.35	6.19
3500	0.79	174.92	5.99	2.18	6.37
3600	0.79	170.77	5.85	3.99	7.08
3700	0.80	166.54	5.74	5.80	8.16
3800	0.80	162.52	5.73	7.56	9.49
3900	0.80	158.74	5.73	9.22	10.86
4000	0.80	155.06	5.68	10.84	12.24
4100	0.80	151.49	5.69	12.38	13.62
4200	0.80	148.28	5.70	13.78	14.91
4300	0.80	146.02	5.73	14.88	15.95
4400	0.80	144.12	5.60	15.84	16.80
4500	0.82	142.31	5.41	16.66	17.52
4600	0.83	140.78	5.29	17.42	18.21
4700	0.83	139.65	5.14	17.95	18.67
4800	0.84	138.75	4.99	18.38	19.05

LMX243x UTCSP FinRF Input Impedance Table (Continued) Vcc = EN = 2.50V, T_A = +25°C

f _{FinRF}	IΓI	Angle (Γ)	Re {ZFinRF}	Im {ZFinRF}	IZFinRFI
(MHz)		(°)	(Ω)	(Ω)	(Ω)
4900	0.84	137.79	4.84	18.85	19.46
5000	0.84	136.82	4.92	19.79	20.39
5100	0.84	135.77	4.88	18.89	19.51
5200	0.84	134.64	4.99	20.44	21.04
5300	0.84	133.33	5.11	21.16	21.77
5400	0.84	131.68	5.25	21.96	22.58
5500	0.83	129.77	5.43	23.01	23.64
5600	0.83	127.55	5.70	24.16	24.82
5700	0.82	125.41	6.03	25.33	26.04
5800	0.82	123.35	6.42	26.41	27.18
5900	0.81	121.68	6.75	27.30	28.12
6000	0.80	120.42	7.11	28.00	28.89

LMX243x TSSOP FinRF Input Impedance Table Vcc = EN = 2.50V, $T_A = +25^{\circ}C$

f _{FinRF} (MHz)	lΓl	Angle (Γ) (°)	Re {ZFinRF} (Ω)	Im {ZFinRF} (Ω)	l ZFinRF l (Ω)
100	0.86	-12.47	214.61	-314.33	380.61
200	0.85	-15.35	166.75	-270.14	317.46
300	0.84	-19.41	122.76	-228.38	259.28
400	0.83	-24.22	89.48	-193.48	213.17
500	0.82	-28.97	67.73	-167.98	181.12
600	0.82	-33.65	52.07	-148.64	157.50
700	0.82	-38.37	41.64	-131.88	138.30
800	0.82	-43.22	34.60	-117.36	122.35
900	0.81	-48.37	29.69	-104.33	108.47
1000	0.80	-53.84	25.88	-92.74	96.28
1100	0.79	-59.80	22.78	-82.21	85.31
1200	0.78	-66.29	20.17	-72.67	75.42
1300	0.77	-73.30	17.88	-64.06	66.51
1400	0.76	-80.74	15.93	-56.21	58.42
1500	0.75	-88.27	14.50	-49.36	51.45
1600	0.74	-95.87	13.27	-43.30	45.29
1700	0.73	-103.41	12.42	-37.96	39.94
1800	0.72	-110.77	11.67	-33.20	35.19
1900	0.71	-118.23	11.20	-28.78	30.88
2000	0.70	-125.46	11.25	-24.74	27.18
2100	0.68	-131.35	11.37	-21.60	24.41
2200	0.68	-137.19	10.94	-18.79	21.74
2300	0.68	-143.41	10.37	-15.88	18.97
2400	0.69	-149.45	9.70	-13.18	16.36
2500	0.71	-156.15	8.62	-10.26	13.40
2600	0.73	-163.87	7.79	-6.92	10.42
2700	0.74	-171.33	7.47	-3.71	8.34
2800	0.75	-178.24	7.30	0.76	7.34
2900	0.75	174.91	7.24	2.18	7.56
3000	0.75	168.09	7.33	5.12	8.94
3100	0.74	161.11	7.53	8.14	11.09
3200	0.74	153.92	7.83	11.30	13.75
3300	0.74	146.42	8.19	14.72	16.85
3400	0.74	138.67	8.59	18.36	20.27
3500	0.74	130.89	8.97	22.22	23.96
3600	0.75	123.33	9.30	26.23	27.83
3700	0.76	116.17	9.54	30.32	31.79
3800	0.77	109.55	9.74	34.42	35.77
3900	0.78	103.54	9.91	38.43	39.69
4000	0.79	98.25	10.20	42.23	43.44
4100	0.79	93.38	10.71	45.97	47.20
4200	0.79	88.86	11.70	49.59	50.95
4300	0.78	85.10	13.43	52.63	54.32
4400	0.77	82.09	14.79	55.23	57.18
4500	0.77	78.59	16.13	58.48	60.66
4600	0.76	74.73	17.90	62.30	64.82
4700	0.76	70.66	19.89	66.66	69.56
4800	0.75	66.05	22.50	72.05	75.48

LMX243x TSSOP FinRF Input Impedance Table (Continued) Vcc = EN = 2.50V, $T_A = +25^{\circ}C$

f _{FinRF}	IΓI	Angle (Γ)	Re {ZFinRF}	Im {ZFinRF}	IZFinRFI
(MHz)		(°)	(Ω)	(Ω)	(Ω)
4900	0.75	61.68	25.37	77.73	81.77
5000	0.75	57.35	28.56	84.19	88.90
5100	0.76	53.11	31.70	91.39	96.73
5200	0.77	48.79	34.78	100.34	106.20
5300	0.78	43.56	40.56	112.59	119.67
5400	0.78	38.11	52.53	125.62	136.16
5500	0.76	32.89	71.05	135.74	153.21
5600	0.73	27.85	95.57	142.32	171.43
5700	0.71	21.89	133.18	141.32	194.19
5800	0.68	15.38	177.08	116.75	212.10
5900	0.65	9.47	207.23	77.49	221.24
6000	0.64	4.15	222.92	35.24	225.69

LMX243x UTCSP FinIF Input Impedance Table Vcc = EN = 2.50V, $T_A = +25^{\circ}C$

f _{FinIF}	lΓl	Angle (┌)	Re {ZFinIF}	Im {ZFinIF}	ZFinIF
(MHz)		(°)	(Ω)	(Ω)	(Ω)
100	0.87	-6.19	446.34	-341.41	561.94
200	0.86	-8.10	353.77	-328.44	482.73
300	0.85	-10.98	257.50	-300.77	395.94
400	0.84	-14.21	188.33	-268.39	327.87
500	0.83	-17.67	141.63	-235.88	275.13
600	0.83	-21.32	109.44	-206.86	234.03
700	0.82	-25.13	86.57	-182.41	201.91
800	0.81	-29.04	70.47	-161.46	176.17
900	0.80	-32.99	58.90	-144.27	155.83
1000	0.79	-36.73	50.96	-130.45	140.05
1100	0.79	-40.28	44.21	-120.14	128.02
1200	0.79	-44.11	37.38	-111.08	117.20
1300	0.79	-48.38	31.82	-101.96	106.81
1400	0.79	-52.91	27.95	-93.09	97.20
1500	0.78	-57.26	25.34	-85.47	89.15
1600	0.77	-61.56	23.28	-78.74	82.11
1700	0.77	-66.01	20.98	-72.74	75.71
1800	0.77	-71.39	18.40	-66.32	68.83
1900	0.77	-77.74	15.22	-59.40	61.32
2000	0.76	-84.72	15.02	-52.48	54.59
2100	0.73	-92.59	14.39	-46.17	48.36
2200	0.71	-100.18	14.07	-40.46	42.84
2300	0.69	-107.33	13.94	-35.79	38.41
2400	0.68	-114.48	13.37	-31.55	34.27
2500	0.68	-118.42	12.71	-28.62	31.32

LMX243x TSSOP FinIF Input Impedance Table Vcc = EN = 2.50V, T_A = +25°C

f _{FinIF}	IΓI	Angle (Γ)	Re {ZFinIF}	Im {ZFinIF}	IZFinIFI
(MHz)		(°)	(Ω)	(Ω)	(Ω)
100	0.87	-7.11	400.44	-348.14	530.62
200	0.86	-9.92	288.69	-318.81	430.10
300	0.85	-13.64	198.42	-281.45	344.36
400	0.84	-17.47	141.73	-246.13	284.02
500	0.84	-21.42	105.75	-214.58	239.22
600	0.83	-25.39	82.00	-188.43	205.50
700	0.83	-29.46	65.48	-166.34	178.76
800	0.82	-33.67	53.78	-147.46	156.96
900	0.81	-37.99	45.17	-131.83	139.35
1000	0.80	-42.47	38.82	-117.87	124.10
1100	0.79	-46.96	33.93	-106.36	111.64
1200	0.79	-51.67	29.53	-96.20	100.63
1300	0.78	-57.02	25.26	-86.47	90.08
1400	0.77	-63.11	22.15	-76.93	80.06
1500	0.76	-69.26	20.49	-68.42	71.42
1600	0.74	-74.82	19.54	-61.59	64.62
1700	0.74	-79.79	17.70	-56.35	59.06
1800	0.74	-86.55	15.09	-50.74	52.94
1900	0.74	-94.37	13.38	-44.56	46.53
2000	0.73	-101.95	12.62	-38.87	40.87
2100	0.72	-108.92	12.21	-34.18	36.30
2200	0.71	-115.63	11.65	-30.11	32.29
2300	0.71	-123.23	11.13	-25.97	28.25
2400	0.69	-131.44	11.08	-21.74	24.40
2500	0.67	-138.35	11.54	-18.31	21.64

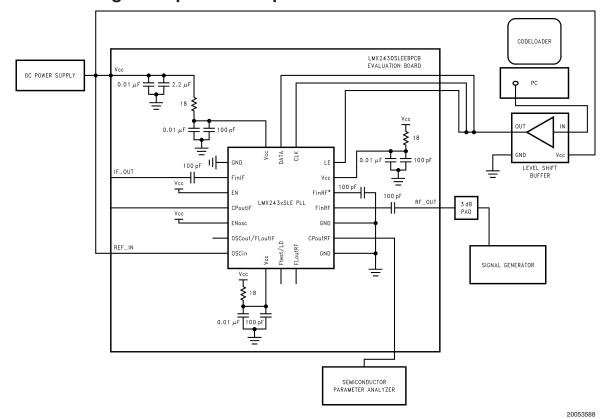
LMX243x UTCSP OSCin Input Impedance Table Vcc = EN = 2.50V, T_A = +25°C

f _{oscin} (MHz)		ENosc = 1			ENosc = 0		
	Re {ZOSCin}	Im {ZOSCin}	IZOSCinl	Re {ZOSCin}	Im {ZOSCin}	IZOSCinl	
	(Ω)						
5.0	5032.01	-10120.58	11302.53	2641.63	-13293.58	13553.50	
7.5	2529.17	-7382.23	7803.46	1108.82	-8932.61	9001.17	
10.0	1412.10	-5693.56	5866.06	526.74	-6461.11	6482.55	
12.5	1051.18	-4930.80	5041.60	330.16	-5452.11	5462.10	
15.0	710.63	-4099.58	4160.72	233.66	-4455.98	4462.10	
17.5	545.87	-3584.60	3625.92	212.67	-3822.33	3828.24	
20.0	442.32	-3125.21	3156.35	192.16	-3306.06	3311.64	
22.5	314.15	-2806.10	2823.63	112.07	-2963.67	2965.79	
25.0	316.48	-2518.94	2538.75	143.65	-2657.93	2661.81	
27.5	223.49	-2280.02	2290.95	84.09	-2405.34	2406.81	
30.0	196.90	-2105.11	2114.30	40.38	-2196.07	2196.45	
32.5	175.38	-1942.45	1950.35	77.29	-2044.88	2046.34	
35.0	158.95	-1816.83	1823.77	67.31	-1898.92	1900.12	
37.5	137.80	-1701.59	1707.16	51.11	-1775.84	1776.58	
40.0	114.20	-1573.28	1577.42	50.39	-1652.06	1652.83	

LMX243x TSSOP OSCin Input Impedance Table Vcc = EN = 2.50V, T_A = +25°C

f _{OSCin} (MHz)		ENosc = 1			ENosc = 0		
	Re {ZOSCin}	Im {ZOSCin}	IZOSCinl	Re {ZOSCin}	Im {ZOSCin}	IZOSCinl	
	(Ω)						
5.0	1111.30	-4814.09	4940.69	654.13	-7449.33	7477.99	
7.5	628.81	-3411.80	3469.26	388.42	-5150.60	5165.22	
10.0	359.99	-2623.46	2648.04	237.72	-3892.18	3899.44	
12.5	284.12	-2065.00	2084.46	159.00	-2988.66	2992.88	
15.0	203.53	-1801.24	1812.70	152.53	-2597.16	2601.63	
17.5	134.32	-1548.50	1554.32	82.41	-2222.34	2223.86	
20.0	109.85	-1343.30	1347.78	60.86	-1956.99	1957.94	
22.5	80.56	-1192.73	1195.45	47.56	-1730.53	1731.18	
25.0	69.37	-1063.72	1065.98	47.47	-1553.43	1554.15	
27.5	60.10	-973.84	975.70	37.83	-1414.54	1415.04	
30.0	50.30	-890.31	891.73	34.80	-1290.03	1290.50	
32.5	45.52	-816.01	817.28	29.72	-1188.88	1189.25	
35.0	41.55	-758.24	759.38	31.50	-1096.89	1097.35	
37.5	37.73	-707.57	708.57	23.04	-1024.88	1025.14	
40.0	36.09	-661.87	662.86	22.61	-963.11	963.38	

LMX243x Charge Pump Test Setup



The block diagram above illustrates the setup required to measure the LMX243x device's RF charge pump sink current. The same setup is used for the LMX2430TM Evaluation Board. The purpose of this test is to assess the functionality of the RF charge pump. The IF charge pump is evaluated in the same way.

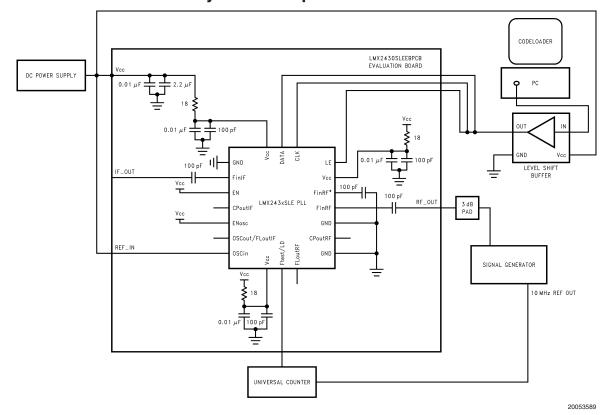
This setup uses an open loop configuration. A power supply is connected to Vcc. By means of a signal generator, a 10 MHz signal is typically applied to the FinRF pin. The signal is one of two inputs to the phase/ frequency detector (PFD). The 3 dB pad provides a 50Ω match between the PLL and the signal generator. The OSCin pin is tied to Vcc. This establishes the other input to the PFD. Alternatively, this input can be tied directly to the ground plane. The EN and ENosc pins are also both tied to Vcc. A Semiconductor Parameter Analyzer is connected to the CPoutRF pin and used to measure the sink, source, and TRI-STATE leakage currents.

Let F_r represent the frequency of the signal applied to the OSCin pin, which is simply zero in this case (DC), and let F_p represent the frequency of the signal applied to the FinRF

pin. The PFD is sensitive to the rising edges of F_r and F_p . Assuming positive VCO characteristics (RF_CPP bit = 1); the charge pump turns ON, and sinks current when the first rising edge of F_p is detected. Since F_r has no rising edge, the charge pump continues to sink current indefinitely. In order to measure the RF charge pump source current, the RF_CPP bit is simply set to 0 (negative VCO characteristics) in CodeLoader. Similarly, in order to measure the TRI-STATE leakage current, the RF_CPT bit is set to 1.

The measurements are typically taken over supply voltage and temperature. The measurements are also typically taken at the HIGH and LOW charge pump current gains. The charge pump current gain can be controlled by the RF_CPG bit in CodeLoader. Once the charge pump currents are determined, the (i) charge pump output current magnitude variation versus charge pump output voltage, (ii) charge pump output sink current versus charge pump output source current mismatch, and (iii) charge pump output current magnitude versus tempeature, can be calculated. Refer to the **Charge Pump Current Specifications Definition** for more details.

LMX243x FinRF Sensitivity Test Setup



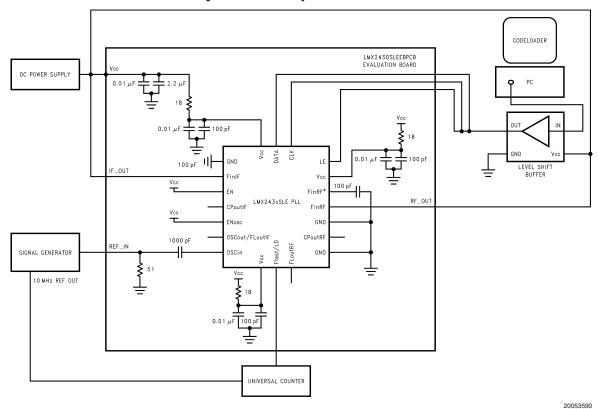
The block diagram above illustrates the setup required to measure the LMX243x device's RF input sensitivity level. The same setup is used for the LMX2430TM Evaluation Board. The purpose of this test is to measure the acceptable signal level to the FinRF input of the PLL chip. Outside the acceptable signal range, the feedback divider begins to divide incorrectly and miscount the frequency. The FinIF sensitivity is evaluated in the same way.

The setup uses an open loop configuration. A power supply is connected to Vcc. The IF PLL is powered down (IF_PD bit = 1). By means of a signal generator, an RF signal is applied to the FinRF pin. The 3 dB pad provides a 50Ω match between the PLL and the signal generator. The EN, ENosc, and OSCin pins are all tied to Vcc. The N value is typically set to 10000 in CodeLoader, i.e. RF_B word = 156 and RF_A word = 16 for RF_P bit = 0 (LMX2434) or RF_P bit = 1 (LMX2430 and LMX2433). The feedback divider output is routed to the Ftest/LD pin by selecting the RF_N/2 Frequency word (MUX[3:0] word = 15) in CodeLoader. A Universal Counter is connected to the Ftest/LD pin and used to monitor the output frequency of the feedback divider. The

expected frequency should be the signal generator frequency divided by twice the corresponding counter value, i.e. 20000. The factor of two comes in because the LMX43x device has an internal /2 circuit which is used to provide a 50% duty cycle.

Sensitivity is typically measured over frequency, supply voltage and temperature. In order to perform the measurement, the temperature, frequency, and supply voltage is set to a fixed value and the power level of the signal at FinRF is varied. Sensitivity is reached when the frequency error of the divided RF input is greater than or equal to 1 Hz. The power attenuation from the cable and the 3 dB pad must be accounted for. The feedback divider will actually miscount if too much or too little power is applied to the FinRF input. Therefore, the allowed input power level will be bounded by the upper and lower sensitivity limits. In a typical application, if the power level to the FinRF input approaches the sensitivity limits, this can introduce spurs or cause degradation to the phase noise. When the power level gets even closer to these limits, or exceeds it, then the RF PLL loses lock.

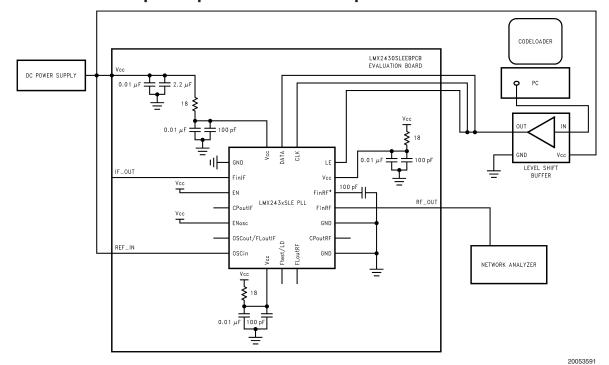
LMX243x OSCin Sensitivity Test Setup



The block diagram above illustrates the setup required to measure the LMX243x device's OSCin buffer sensitivity level. The same setup is used for the LMX2430TM Evaluation Board. This setup is similar to the FinRF sensitivity setup except that the signal generator is now connected to the OSCin pin and both Fin pins are tied to Vcc. The 51Ω shunt resistor matches the OSCin input to the signal generator. The R counter is typically set to 1000, i.e. RF_R word = 1000 or IF_R word = 1000. The reference divider output is routed to the Ftest/LD pin by selecting the RF_R/2 Frequency word (MUX[3:0] word = 14) or the IF_R/2 Frequency word (MUX[3:0] word = 12) in CodeLoader. A Universal Counter is connected to the Ftest/LD pin and is used to monitor the

output frequency of the reference divider. The expected frequency should be the signal generator frequency divided by twice the corresponding counter value, i.e. 2000. The factor of two comes in because the LMX243x device has an internal /2 circuit which is used to provide a 50% duty cycle. In a similar way, sensitivity is typically measured over frequency, supply voltage and temperature. In order to perform the measurement, the temperature, frequency, and supply voltage is set to a fixed value and the power level (voltage level) of the signal at OSCin is varied. Sensitivity is reached when the frequency error of the divided input signal is greater than or equal to 1 Hz.

LMX243x FinRF Input Impedance Test Setup



The block diagram above illustrates the setup required to measure the LMX243x device's RF input impedance. The same setup is used for the LMX2430TM Evaluation Board. Measuring the device's input impedance facilitates the design of appropriate matching networks to match the PLL to the VCO, or in more critical situations, to the characteristic impedance of the printed circuit board (PCB) trace, to prevent undesired transmission line effects. The FinIF input impedance is evaluated in the same way.

Before the actual measurements are taken, the Network Analyzer needs to be calibrated, i.e. the error coefficients need to be calculated. The Network Analyzer's calibration standard is used to calculate these coefficients. The calibration standard includes an open, short and a matched load. A 1-port calibration is implemented here.

To calculate the coefficients, the PLL chip is first removed from the PCB. A piece of semi-rigid coaxial cable is then soldered to the pad on the PCB which is equivalent to the FinRF pin on the PLL chip. Proper grounding near the exposed tip of the semi-rigid coaxial cable is required for accurate results. Note that the DC blocking capacitor is removed for this test. The Network Analyzer port is then connected to the other end of the semi-rigid coaxial cable. In

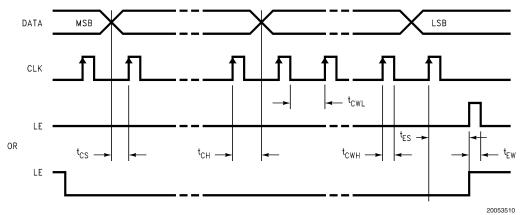
this way, the semi-rigid coaxial cable acts as a transmission line. This transmission line adds electrical length and produces an offset from the reference plane of the Network Analyzer; therefore, it must be included in the calibration. The desired operating frequency is then set. The typical frequency range selected for the LMX243x device's RF synthesizer is from 100 MHz to 6000 MHz.

The Network Analyzer calculates the calibration coefficients based on the measured S_{11} parameters. With this all done, calibration is now complete.

The PLL chip is then placed on the PCB. A power supply is then connected to Vcc. The EN, ENosc, and OSCin pins are all tied to Vcc. Alternatively, the OSCin pin can be tied to ground. In this setup, the complementary input (FinRF*) is AC coupled to ground. With the Network Analyzer still connected to the semi-rigid coaxial cable, the measured FinRF impedance is displayed.

The OSCin input impedance is measured in the same way. The impedance is measured when the oscillator buffer is powered up (ENosc is set HIGH) and when the oscillator buffer is powered down (ENosc pin is set LOW).

LMX243x Serial Data Input Timing



Notes

- 1. DATA is clocked into the 24-bit shift register on the rising edge of CLK
- 2. The MSB of DATA is shifted in first.

1.0 Functional Description

The basic phase-lock-loop (PLL) configuration consists of a high-stability crystal reference oscillator, a frequency synthesizer such as the National Semiconductor LMX243x, a voltage controlled oscillator (VCO), and a passive loop filter. The frequency synthesizer includes a phase detector, current mode charge pump, programmable reference R and feedback N frequency dividers. The VCO frequency is established by dividing the crystal reference signal down via the reference divider to obtain a comparison reference frequency. This reference signal, fr, is then presented to the input of a phase/ frequency detector and compared with the feedback signal, fp, which was obtained by dividing the VCO frequency down by way of the feedback divider. The phase/ frequency detector measures the phase error between the f_r and fo signals and outputs control signals that are directly proportional to the phase error. The charge pump then pumps charge into or out of the loop filter based on the magnitude and direction of the phase error. The loop filter converts the charge into a stable control voltage for the VCO. The phase/frequency detector's function is to adjust the voltage presented to the VCO until the feedback signal's frequency and phase match that of the reference signal. When this "Phase-Locked" condition exists, the VCO frequency will be N times that of the comparison frequency, where N is the feedback divider ratio.

1.1 REFERENCE OSCILLATOR INPUT

The reference oscillator frequency for both the RF and IF PLLs is provided from an external reference via the OSCin pin. The reference buffer circuit supports input frequencies from 5 to 40 MHz with a minimum input sensitivity of 0.5 $\rm V_{PP}$. The reference buffer circuit has an approximate Vcc/2 input threshold and can be driven from an external AC coupled source. Typically, the OSCin pin is connected to the output of a crystal oscillator.

1.2 REFERENCE DIVIDERS (R COUNTERS)

The reference dividers divide the reference input signal, OSCin, by a factor of R. The output of the reference divider circuits feeds the reference input of the phase detector. This reference input to the phase detector is often referred to as the comparison frequency. The divide ratio should be chosen such that the maximum phase comparison frequency ($f_{COM^{PRF}}$) of 10 MHz is not exceeded.

The RF and IF reference dividers are each comprised of 15-bit CMOS binary counters that support a continuous integer divide ratio from 3 to 32767. The RF and IF reference divider circuits are clocked by the output of the reference buffer circuit which is common to both. Refer to **Sections 2.4.1** and **2.7.1** for details on how to program the RF_R and IF_R counters.

1.3 PRESCALERS

The FinRF and FinIF input pins drive the input of a differential-pair amplifier. The output of the differential-pair amplifier drives a chain of D-type flip-flops in a dual modulus configuration. The output of the prescaler is used to clock the subsequent feedback dividers. The RF PLL complementary inputs can be driven differentially, or the negative input can be AC coupled to ground through an external capacitor for single ended configuration. A 16/17 or a 32/33 prescale ratio can be selected for the 5.0 GHz LMX2434 RF synthesizer. An 8/9 or a 16/17 prescale ratio can be selected for both the

LMX2430 and LMX2433 RF synthesizers. The IF PLL is single ended. An 8/9 or a 16/17 prescale ratio can be selected for the IF synthesizer.

1.4 PROGRAMMABLE FEEDBACK DIVIDERS (N COUNTERS)

The programmable feedback dividers operate in concert with the prescalers to divide the input signal, Fin, by a factor of N. The output of the programmable reference divider is provided to the feedback input of the phase detector circuit. The divide ratio should be chosen such that the maximum phase comparison frequency (f_{COMPRF} or f_{COMPIF}) of 10 MHz is not exceeded.

The programmable feedback divider circuit is comprised of an A counter (swallow counter) and a B counter (programmble binary counter). For both the LMX2430 and LMX2433, the RF_A counter is a 4-bit swallow counter, programmable from 0 to 15. The LMX2434 RF_A counter is a 5-bit swallow counter, programmable from 0 to 31. The LMX243x IF_A counter is a 4-bit swallow counter, programmable from 0 to 15. For both the LMX2430 and LMX2433, the RF_B counter is a 15-bit binary counter, programmable from 3 to 32767. The LMX2434 RF_B counter is a 14-bit binary counter, programmable from 3 to 16383. The LMX243x IF_B is a 14-bit binary counter programmable from 3 to 16383. A continuous integer divide ratio is achieved if $N \ge P * (P-1)$, where P is the value of the prescaler selected. Divide ratios less than the minimum continuous divide ratio are achievable as long as the binary programmable counter value is greater than the swallow counter value (B \geq A). Refer to Sections 2.5.1.1, 2.5.1.2, 2.5.2.1, 2.5.2.2, 2.8.1, and 2.8.2 for details on how to program the A and B counters. The following equations are useful in determining and programming a particular value of N:

 $N = (P \times B) + A$

 $Fin = N x f_{COMP}$

Definitions:

f_{COMP}: RF or IF phase detector comparison frequency

Fin: RF or IF input frequency
A: RF_A or IF_A counter value
B: RF_B or IF_B counter value

P: Preset modulus of the dual modulus prescaler

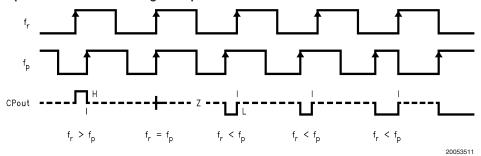
LMX2430 RF synthesizer: P = 8 or 16 LMX2433 RF synthesizer: P = 8 or 16 LMX2434 RF synthesizer: P = 16 or 32 LMX243x IF synthesizer: P = 8 or 16

1.5 PHASE/ FREQUENCY DETECTORS

The RF and IF phase/ frequency detectors (PFD) are driven from their respective N and R counter outputs. The maximum frequency for both the RF and IF phase detector inputs is 10 MHz. The PFD outputs control the respective charge pumps. The polarity of the pump-up or pump-down control signals are programmed using the RF_CPP or IF_CPP control bits, depending on whether the RF or IF VCO characteristics are positive or negative. Refer to Sections 2.4.2 and 2.7.2 for more details. The PFDs have a detection range of -2π to $+2\pi$. The PFDs also receive a feedback signal from the charge pump in order to eliminate dead zone.

1.0 Functional Description (Continued)

1.5.1 Phase Comparator and Internal Charge Pump Characteristics



Notes:

- 1. The minimum width of the pump-up and pump-down current pulses occur at the CPoutRF or CPoutIF pins when the loop is phase locked.
- 2. The diagram assumes positive VCO characteristics, i.e. RF_CPP or IF_CPP = 1.
- 3. fr is the PFD input from the reference divider (R counter).
- 4. fp is the PFD input from the programmable feedback divder (N counter).
- 5. CPout refers to either the RF or IF charge pump output.

1.6 CHARGE PUMPS

The charge pump directs charge into or out of an external loop filter. The loop filter converts the charge into a stable control voltage which is applied to the tuning input of the VCO. The charge pump steers the VCO control voltage towards Vcc during pump-up events and towards GND during pump-down events. When locked, CPoutRF or CPoutIF are primarily in a TRI-STATE mode with small corrections occuring at the phase comparator rate. The charge pump output current magnitude can be selected by toggling the RF_CPG or IF_CPG control bits.

1.7 MICROWIRE SERIAL INTERFACE

The programmable register set is accessed via the MI-CROWIRE serial interface. A low voltage logic interface allows direct connection to 1.8V devices. The interface is comprised of three signal pins: CLK, DATA and LE. Serial data is clocked into the 24-bit shift register on the rising edge of CLK. The last two bits decode the internal control register address. When LE transitions HIGH, DATA stored in the shift register is loaded into one of four control registers depending on the state of the address bits. The MSB of DATA is loaded in first. The synthesizers can be programmed even in power down mode. A complete programming description is provided in Section 2.0 Programming Description.

1.8 MULTI-FUNCTION OUTPUTS

The LMX243x device's Ftest/LD output pin is a multi-function output that can be configured as a general purpose CMOS TRI-STATE output, push-pull analog lock detect output, open-drain analog lock detect output, digital filtered lock detect output, or used to monitor the output of the various reference divider (R counter) or feedback divider (N counter) circuits. The Ftest/LD control word is used to select the desired output function. When the PLL is in powerdown mode, the Ftest/LD output is disabled and is in a high impedance state. A complete programming description of the multi-function output is provided in **Section 2.10**.

1.8.1 Push-Pull Analog Lock Detect Output

An analog lock detect status generated from the phase detector is available on the Ftest/LD output pin if selected. A push-pull configuration can be selected for the lock detect output signal. With this configuration, the lock detect output goes HIGH when the charge pump is inactive. It goes LOW when the charge pump is active during a comparison cycle. Narrow low going pulses are observed when the charge pump turns on.

There are three separate push-pull analog lock detect signals that are routed to the multiplexer. Two of these monitor the lock status of the individual synthesizers. The third detects the condition when both the RF and IF synthesizers are in a locked state. External circuitry is required to provide a steady DC signal to indicate when the PLL is in a locked state. Refer to **Section 2.10** for details on how to program the different push-pull analog lock detect options.

1.8.2 Open-Drain Analog Lock Detect Output

The lock detect output can be an open-drain configuration. In this configuration, the lock detect output goes to a high impedance state when the charge pump is inactive. It goes LOW when the charge pump is active during a comparison cycle. When a pull-up resistor is used, narrow low going pulses are observed when the charge pump turns on.

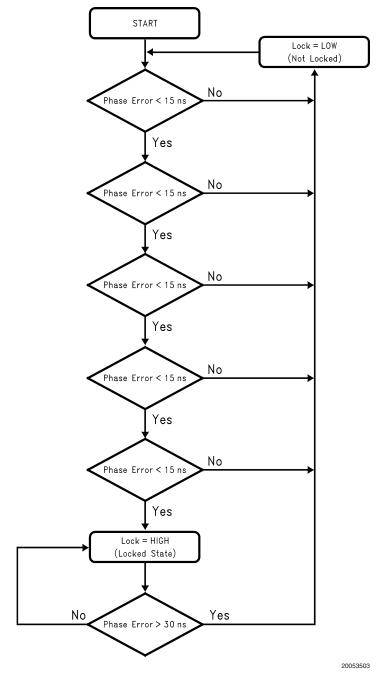
Similarly, three separate open-drain analog lock detect signals are routed to the multiplexer. Two of these monitor the lock status of the individual synthesizers. The third detects the condition when both the RF and IF synthesizers are in a locked state. External circuitry is required to provide a steady DC signal to indicate when the PLL is in a locked state. Refer to **Section 2.10** for details on how to program the different open-drain analog lock detect options.

1.0 Functional Description (Continued)

1.8.3 Digital Filtered Lock Detect Output

A digital filtered lock detect status generated from the phase detector is also available on the Ftest/LD output pin if selected. The lock detect digital filter compares the difference bewteen the phases of the inputs to the PFD to an RC generated delay of approximately 15 ns. If the phase error is less than the 15 ns RC delay for 5 consecutive reference

cycles, the PLL enters a locked state (HIGH). Once in lock, the RC delay is changed to approximately 30 ns. Once the phase error becomes greater than the 30 ns RC delay, the PLL falls out of lock (LOW). When the PLL is in powerdown mode, the Ftest/LD output is forced LOW. A flow chart of the digital filtered lock detect output is shown below.



Similarly, three separate digital filtered lock detect signals are routed to the multiplexer. Two of these monitor the lock status of the individual synthesizers. The third detects the condition when both the RF and IF synthesizers are in a

locked state. External circuitry is not required when the digital filtered lock detect option is selected. Refer to **Section 2.10** for details on how to program the different digital filtered lock detect options.

1.0 Functional Description (Continued)

1.8.4 Reference Divider and Feedback Divider Output

The outputs of the various N and R dividers can be monitored by selecting the appropriate Ftest/LD word. This is essential when performing OSCin or Fin sensitivity measurements. Refer to the LMX243x FinRF Sensitivity Test Setup or LMX243x OSCin Sensitivity Test Setup sections for more details. Note, the R and N outputs that are routed to the Ftest/LD are R/2 and N/2 respectively. The internal /2 circuit is used to provide a 50% duty cycle. Refer to Section 2.10 for more details on how to route the appropriate divider output to the Ftest/LD pin.

1.9 FASTLOCK OUTPUT

The LMX243x Fastlock feature allows a faster loop response time during lock aquisition. The loop response time (lock time) can be approximately halved if the loop bandwidth is doubled. In order to achieve this, the same gain/ phase relationship should be maintained when the loop bandwidth is doubled. When the FLoutRF or OSCout/ FLoutIF pins are configured as FastLock outputs, an open drain device is enabled. The open drain device switches in a resistor parallel, and of equal value, to R2 of the external loop filter. The loop bandwidth is effectively doubled and stability is maintained. Once locked to the correct frequency, the PLL will return to a steady state condition. The LMX243x offers two methods to achieve Fastlock: manual and automatic. Manual Fastlock is achieved by increasing the charge pump current from 1 mA (RF_CPG/ IF_CPG Bit = 0) in the steady state mode, to 4 mA (RF_CPG/ IF_CPG Bit = 1) in Fastlock mode. Automatic Fastlock is achieved by programming the timeout counter register (RF_TOC/ IF_TOC) with the appropriate number of phase comparison cycles that the RF/ IF synthesizer will spend in the Fastlock state. Refer to Sections 2.6 and 2.9 for details on how to configure the FLoutRF or OSCout/ FLoutIF output to an open drain Fastlock output.

1.10 COUNTER RESET

When the RF_RST/ IF_RST bit is enabled, both the feedback divider (RF_N/ IF_N) and reference divider (RF_R/ IF_R) are held at their load point. When the device is programmed to normal operation, both the feedback divider and reference divder are enabled and resume counting in close alignment to each other. Refer to **Sections 2.4.5 and 2.7.5** for more details.

1.11 POWER CONTROL

The LMX243x device can be asynchronously powered down when the EN pin is set LOW, independent of the state of the powerdown bits. Note that the OSCout/ FLoutIF pin can still

be enabled if the ENosc pin is set HIGH, independent of the state of the EN pin. This capability allows the oscillator buffer to be used as a crystal oscillator. When EN is set HIGH, powerdown is controlled through the MICROWIRE. The powerdown word is comprised of the RF_PD/ IF_PD bit, in conjuction with the RF_CPT/ IF_CPT bit. The powerdown control word is used to set the operating mode of the device. Refer to Sections 2.4.4, 2.5.4, 2.7.4, and 2.8.4 for details on how to program the RF or IF powerdown bits.

When either synthesizer is powered down, the respective prescaler, phase detector, and charge pump circuit is disabled. The CPoutRF/ CPoutIF, FinRF/ FinIF, and FinRF* pins are all forced to a high impedance state. The reference divider and feedback divider circuits are held at the load point during powerdown. The oscillator buffer is disabled when the ENosc pin is set LOW. The OSCin pin is forced to a HIGH state through an approximate 100 $k\Omega$ resistance when this condition exists. When either synthesizer is activated, the respective prescaler, phase detector, charge pump circuit, and the oscillator buffer are all powered up. The feedback divider and reference divider are held at their load point. This allows the reference oscillator, feedback divider, reference divider and prescaler circuitry to reach proper bias levels. After a finite delay, the feedback and reference dividers are enabled and they resume counting in close alignment (the maximum error is one prescaler cycle). The MICROWIRE control register remains active and capable of loading and latching data while in powerdown

1.11.1 Synchronous Powerdown Mode

In this mode, the powerdown function is gated by the charge pump. When the device is configured for synchronous powerdown, the device will enter the powerdown mode upon completion of the next charge pump pulse event.

1.11.2 Asynchronous Powerdown Mode

In this mode, the powerdown function is NOT gated by the completion of a charge pump pulse event. When the device is configured for asynchronous powerdown, the part will go into powerdown mode immediately.

EN Pin	RF_CPT/ IF_CPT Bit	RF_PD/ IF_PD Bit	Operating Mode
0	Х	Х	Asynchronous Powerdown
1	0	0	PLL Active.
			Normal Operation
1	1	0	PLL Active.
			Charge Pump Output in High Impedance State
1	0	1	Synchronous Powerdown
1	1	1	Asynchronous Powerdown

Note: X refers to a don't care condition.

2.0 Programming Description

2.1 MICROWIRE INTERFACE

The 24-bit shift register is loaded via the MICROWIRE interface. The shift register consists of a 21-bit *DATA[20:0] FIELD* and a 3-bit *ADDRESS[2:0] FIELD* as shown below. The ADDRESS FIELD is used to decode the internal control register address. When LE transitions HIGH, DATA stored in the shift register is loaded into one of 6 control registers depending on the state of the ADDRESS bits. The MSB of DATA is loaded into the shift register first. The DATA FIELD assignments are shown in **Section 2.3 CONTROL REGISTER CONTENT MAP**.

MSB			LSB
	DATA[20:0]		ADDRESS[2:0]
23		3	2 0

2.2 CONTROL REGISTER LOCATION

The ADDRESS[2:0] bits decode the internal register address. The table below shows how the ADDRESS bits are mapped into the target control register.

AD	DRESS[2:0]	Target
	FIELD		Register
0	0	0	R0
0	0	1	R1
0	1	0	R2
0	1	1	R3
1	0	0	R4
1	0	1	R5

2.3 CONTROL REGISTER CONTENT MAP

The control register content map describes how the bits within each control register are allocated to specific control functions. The bits that are marked 0 should be programmed as such to ensure proper device operation.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
										DATA	[20:0]	FIELD											ADDRESS [2:0] FIELD	
R0	мих	[3:2]	RF_ RST	RF_ CPT	RF_ CPG	RF_ CPP							RF	R[14	:0]							0	0	0
R1	RF_ PD	RF_ P						LMX2430/33 RF_B[14:0]								0	0	1						
R1	RF_ PD	RF_ P						LMX2434 LMX2434 RF_B[13:0] RF_A[4:0]							0	0	1							
R2	0	0	0	0	0	0	0	0	0					F	RF_TC	C[11:0	0]					0	1	0
R3	мих	[1:0]	IF_ RST	IF_ CPT	IF_ CPG	IF_ CPP		IF_R[14:0]							0	1	1							
R4	IF_ PD	IF_ P	0					IF_B[13:0] IF_A[3:0]								1	0	0						
R5	0	0	0	0	0	0	0 0 0 0 IF_TOC[11:0]							1	0	1								

2.4 R0 REGISTER

The R0 register contains the RF_R, RF_CPP, RF_CPG, RF_CPT, and RF_RST control words, in addition to two of the four bits that compose the MUX control word. The detailed descriptions and programming information for each control word is discussed in the following sections.

Reg	23	23 22 21 20 19 18 17 16 15 14 13 12 11 10 9 8 7 6 5 4 3										2	1	0
	DATA[20:0] FIELD											ΑĽ	DRES [2:0] FIELD	SS
R0	MUX[3:2]										0	0	0	

2.4.1 RF_R[14:0] - RF Synthesizer Programmable Reference Divider (R Counter) (R0[17:3])

The RF reference divider (RF_R) can be programmed to support divide ratios from 3 to 32767. Divide ratios less than 3 are prohibited.

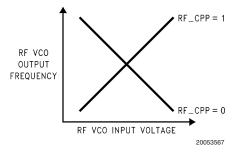
Divide Ratio		RF_R[14:0]													
	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
32767	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1

2.4.2 RF_CPP - RF Synthesizer Phase Detector Polarity (R0[18])

The RF_CPP bit is used to control the RF synthesizer's phase/ frequency detector polarity based on the VCO tuning characteristics.

Control Bit	Register Location	Description	Fund	ction			
			0	1			
RF_CPP	R0[18]	RF Phase/	RF VCO Negative RF VCO Positive				
		Frequency Detector	Tuning	Tuning			
		Polarity	Characteristics	Characteristics			

RF VCO Characteristics



2.4.3 RF_CPG - RF Synthesizer Charge Pump Current Gain (R0[19])

The RF_CPG bit controls the RF synthesizer's charge pump gain. Two gain levels are available.

Control Bit	Register Location	Description	Fund	ction
			0	1
RF_CPG	R0[19]	RF Charge Pump	LOW	HIGH
		Current Gain	1 mA	4 mA

2.4.4 RF_CPT - RF Synthesizer Charge Pump TRI-STATE (R0[20])

The RF_CPT bit allows the charge pump to be switched between a normal operating mode and a high impedance output state. This happens asynchronously with the change in the RF_CPT bit.

Furthermore, the RF_CPT bit operates in conjuction with the RF_PD bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.5.4** for more details on how to program the RF_PD bit.

Control Bit	Register Location	Description	Fund	ction
			0	1
RF_CPT	R0[20]	RF Charge Pump	RF Charge Pump	RF Charge Pump
		TRI-STATE	Normal Operation	Output in High
				Impedance State

2.4.5 RF_RST - RF Synthesizer Counter Reset (R0[21])

The RF_RST bit resets the RF_A, RF_B and RF_R counters. After removing the reset, the RF_A and RF_B counters resume counting in close alignment with the RF_R counter. The maximum error is one prescaler cycle.

Control Bit	Register Location	Description	Fund	ction
			0	1
RF_RST	R0[21]	RF Counter Reset	RF_A, RF_B and	RF_A, RF_B and
			RF_R	RF_R
			Normal Operation	Reset

2.5 R1 REGISTER

The R1 register contains the RF_A, RF_B, RF_P, and RF_PD control words. The RF_A and RF_B control words are used to setup the programmable feedback divider. The detailed descriptions and programming information for each control word is discussed in the following sections.

Reg	23	22	22 21 20 19 18 17 16 15 14 13 12 11 10 9 8 7 6 5 4 3								2	2 1 0									
	DATA[20:0] FIELD									ADDRESS [2:0] FIELD											
R1	RF_ RF_ PD P LMX2430/33 RF_B[14:0]										LMX24 RF_A		0	0	1						
R1	RF_ PD	RF_ P								2434 [13:0]							MX243 F_A[4:		0	0	1

2.5.1 LMX243x RF Synthesizer Swallow Counter

2.5.1.1 RF_A[3:0] - LMX2430/33 RF Synthesizer Swallow Counter (A Counter) (R1[6:3])

The RF_A control word is used to setup the RF synthesizer's A counter. For both the LMX2430 and LMX2433, the A counter is a 4-bit swallow counter used in the programmable feedback divider. The RF_A control word can be programmed to values ranging from 0 to 15.

Divide Ratio			2430/33 A[3:0]	
	3	2	1	0
0	0	0	0	0
1	0	0	0	1
•	•	•	•	•
15	1	1	1	1

2.5.1.2 RF_A[4:0] - LMX2434 RF Synthesizer Swallow Counter (A Counter) (R1[7:3])

The LMX2434 A counter is a 5-bit swallow counter used in the programmable feedback divider. The RF_A control word can be programmed to values ranging from 0 to 31.

Divide Ratio			LMX2434 RF_A[4:0]									
	4	3	2	1	0							
0	0	0	0	0	0							
1	0	0	0	0	1							
•	•	•	•	•	•							
31	1	1 1 1 1 1										

2.5.2 LMX243x RF Synthesizer Programmable Binary Counter

2.5.2.1 RF_B[14:0] - LMX2430/33 RF Synthesizer Programmable Binary Counter (B Counter) (R1[21:7])

The RF_B control word is used to setup the RF synthesizer's B counter. For both the LMX2430 and LMX2433, the B counter is a 15-bit programmable binary counter used in the programmable feedback divider. The RF_B control word can be programmed to values ranging from 3 to 32767. Divide ratios less than 3 are prohibited.

Divide								/IX2430/ F_B[14:							
Ratio	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
32767	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1

2.5.2.2 RF_B[13:0] - LMX2434 RF Synthesizer Programmable Binary Counter (B Counter) (R1[21:8])

The LMX2434 B counter is a 14-bit programmable binary counter used in the programmable feedback divider. The RF_B control word can be programmed to values ranging from 3 to 16383. Divide ratios less than 3 are prohibited.

Divide Ratio							LMX RF_B	2434 [13:0]						
Hatio	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
16383	1	1	1	1	1	1	1	1	1	1	1	1	1	1

2.5.3 LMX243x RF Synthesizer Prescaler Select

2.5.3.1 RF_P - LMX2430/33 RF Synthesizer Prescaler Select (R1[22])

Both the LMX2430 and LMX2433 RF synthesizers utilize a selectable dual modulus prescaler. An 8/9 or a 16/17 prescale ratio can be selected.

Control Bit	Register Location	Description	Fund	ction
			0	1
RF_P	R1[22]	LMX2430/33	8/9 Prescaler	16/17 Prescaler
		RF Prescaler Select	Selected	Selected

2.5.3.2 RF_P - LMX2434 RF Synthesizer Prescaler Select (R1[22])

The LMX2434 RF synthesizer utilizes a selectable dual modulus prescaler. A 16/17 or a 32/33 prescale ratio can be selected.

Control Bit	Register Location	Description	Fund	ction
			0	1
RF_P	R1[22]	LMX2434	16/17 Prescaler	32/33 Prescaler
		RF Prescaler Select	Selected	Selected

2.5.4 RF_PD - RF Synthesizer Powerdown (R1[23])

The RF_PD bit is used to switch the RF PLL between a powered up and powered down mode.

Furthermore, the RF_PD bit operates in conjuction with the RF_CPT bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.4.4** for more details on how to program the RF_CPT bit.

Control Bit	Register Location	Description	Fund	ction
			0	1
RF_PD	R1[23]	RF Powerdown	RF PLL Active	RF PLL Powerdown

2.6 R2 REGISTER

The R2 Register contains the RF_TOC control word. The RF_TOC is used to setup the RF syhnthesizer's Fastlock circuitry. The RF_TOC is a 12-bit binary counter programmable from 0 to 4095.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
										DATA[[20:0]	FIELD											DDRES [2:0] FIELD	SS
R2	R2 0 0 0 0 0 0 0 0 0 0 0 RF_TOC[11:0]												0	1	0									

2.6.1 RF_TOC[0:11] - RF Synthesizer Timeout Counter (R2[14:3])

The FLoutRF pin can be configured as a general purpose CMOS TRI-STATE output or as a Fastlock output by programming the RF_TOC appropriately. When the RF_TOC is programmed from 0 to 3, Automatic Fastlock is disabled, and the FLoutRF pin is either configured as a general purpose CMOS TRI-STATE output or Manual Fastlock is enabled. When the RF_TOC is programmed to 0, the FLoutRF pin will be in TRI-STATE (high impedance) mode. The charge pump current is then the value specified by RF_CPG (R0[19]). When the RF_TOC is programmed to 1, the FLoutRF pin is pulled to a LOW state. The charge pump current is then set to a HIGH gain state (RF_CPG bit = 1). This condition is known as the Manual Fastlock. When the RF_TOC is programmed to 2, the FLout_RF pin will again be pulled to a LOW state, but this time the charge pump current is the value specified by RF_CPG (R0[19]). When the RF_TOC is programmed to 3, the FLoutRF pin is pulled to a HIGH state. Again, the charge pump current is the value specified by RF_CPG (R0[19]). When the RF_TOC is programmed from 4 to 4095, Fastlock is enabled and the FLoutRF pin is pulled to a LOW state. Fastlock will time-out after the specified number of PFD events. At this time, the FLoutRF pin will switch to TRI-STATE (high impedance) mode. The value programmed into RF_TOC represents the number of PFD events that the RF synthesizer will spend in the Fastlock state. Note that any write to the RF_TOC requires a PFD event on the RF synthesizer to latch the contents. This means that writes to the RF_TOC take effect synchronously with the next PFD event.

RF_TOC[11:0]	FastLock Mode	Fastlock Period	FLoutRF Pin	I _{CPoutRF} Magnitude
		[PFD Events]	Functionality/ State	
0	Disabled	N/A	General Purpose.	I _{CPoutRF} magnitude
			High Impedance State	controlled by R0[19]
1	Enabled	N/A	General Purpose.	I _{CPoutRF} = 4 mA
	Manual Fastlock		Logic LOW State	
2	Disabled	N/A	General Purpose.	I _{CPoutRF} magnitude
			Logic LOW State	controlled by R0[19]
3	Disabled	N/A	General Purpose.	I _{CPoutRF} magnitude
			Logic HIGH State	controlled by R0[19]
4	Enabled	4	FastLock.	I _{CPoutRF} = 4 mA
	Automatic Fastlock		Logic LOW State.	Switches to 1 mA after
			Switches to High	4 PFD events
			Impedance after 4 PFD	
			events	
4095	Enabled	4095	FastLock.	I _{CPoutRF} = 4 mA
	Automatic Fastlock		Logic LOW State.	Switches to 1 mA after
			Switches to High	4095 PFD events
			Impedance after 4095	
			PFD events	

2.7 R3 REGISTER

The R3 register contains the IF_R, IF_CPP, IF_CPG, IF_CPT, and IF_RST control words, in addition to two of the four bits that compose the MUX control word. The detailed descriptions and programming information for each control word is discussed in the following sections.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	DATA[20:0] FIELD										AΙ	DDRES [2:0] FIELD	SS											
R3	MUX[1:0]											0	1	1										

2.7.1 IF_R[14:0] - IF Synthesizer Programmable Reference Divider (R Counter) (R3[17:3])

The IF reference divider (IF_R) can be programmed to support divide ratios from 3 to 32767. Divide ratios less than 3 are prohibited.

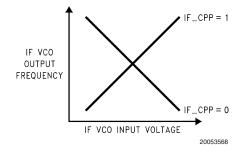
Divide Ratio							IF	_R[14:	0]						
	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
32767	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1

2.7.2 IF_CPP - IF Synthesizer Phase Detector Polarity (R3[18])

The IF_CPP bit is used to control the IF synthesizer's phase/ frequency detector polarity based on the VCO tuning characteristics.

Control Bit	Register Location	Description	Fund	ction
			0	1
IF_CPP	R3[18]	IF Phase/ Frequency	IF VCO Negative	IF VCO Positive
		Detector Polarity	Tuning	Tuning
			Characteristics	Characteristics

IF VCO Characteristics



2.7.3 IF_CPG - IF Synthesizer Charge Pump Current Gain (R3[19])

The IF_CPG bit controls the IF synthesizer's charge pump gain. Two gain levels are available.

Control Bit	Register Location	Description	Fund	ction
			0	1
IF_CPG	R3[19]	IF Charge Pump	LOW	HIGH
		Current Gain	1 mA	4 mA

2.7.4 IF_CPT - IF Synthesizer Charge Pump TRI-STATE (R3[20])

The IF_CPT bit allows the charge pump to be switched between a normal operating mode and a high impedance output state. This happens asynchronously with the change in the IF_CPT bit.

Furthermore, the IF_CPT bit operates in conjuction with the IF_PD bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.8.4** for more details on how to program the IF_PD bit.

Control Bit	Register Location	Description	Fund	ction
			0	1
IF_CPT	R3[20]	IF Charge Pump TRI-STATE	, ,	IF Charge Pump Output in High
				Impedance State

2.7.5 IF_RST - IF Synthesizer Counter Reset (R3[21])

The IF_RST bit resets of the IF_A, IF_B and IF_R counters. After removing the reset, the IF_A and IF_B counters resume counting in close alignment with the IF_R counter. The maximum error is one prescaler cycle.

Control Bit	Register Location	Description	Fund	ction
			0	1
IF_RST	R3[21]	IF Counter Reset	IF_A, IF_B and IF_R	IF_A, IF_B and IF_R
			Normal Operation	Reset

2.8 R4 REGISTER

The R4 register contains the IF_A, IF_B, IF_P, and IF_PD control words. The IF_A and IF_B control words are used to setup the programmable feedback divider. The detailed descriptions and programming information for each control word is discussed in the following sections. R4[21] is always set to 0.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	DATA[20:0] FIELD											ADDRESS [2:0] FIELD												
R4	IF_ PD	IF_ P	0	0 IF_B[13:0] IF_A[3:0]										1	0	0								

2.8.1 IF_A[3:0] - IF Synthesizer Swallow Counter (A Counter) (R4[6:3])

The IF_A control word is used to setup the IF synthesizer's A counter. The A counter is a 4-bit swallow counter used in the programmable feedback divider. The IF_A control word can be programmed to values ranging from 0 to 15.

Divide Ratio		IF_/	A[3:0]	
	3	2	1	0
0	0	0	0	0
1	0	0	0	1
•	•	•	•	•
15	1	1	1	1

2.8.2 IF_B[13:0] - IF Synthesizer Programmable Binary Counter (B Counter) (R4[20:7])

The IF_B control word is used to setup the IF synthesizer's B counter. The B counter is a 14-bit programmable binary counter used in the programmable feedback divider. The IF_B control word can be programmed to values ranging from 3 to 16383. Divide ratios less than 3 are prohibited.

Divide							IF_B[[13:0]						
Ratio	13 12 11 10 9 8 7 6 5 4 3 2										2	1	0	
3	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
16383	1	1	1	1	1	1	1	1	1	1	1	1	1	1

2.8.3 IF_P - IF Synthesizer Prescaler Select (R4[22])

The LMX243x IF synthesizer utilizes a selectable dual modulus prescaler. An 8/9 or a 16/17 prescale ratio can be selected.

Control Bit	Register Location	Description	Fund	ction
			0	1
IF_P	R4[22]	IF Prescaler Select	8/9 Prescaler	16/17 Prescaler
			Selected	Selected

2.8.4 IF_PD - IF Synthesizer Powerdown (R4[23])

The IF_PD bit is used to switch the IF PLL between a powered up and powered down mode.

Furthermore, the IF_PD bit operates in conjuction with the IF_CPT bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.7.4** for more details on how to program the IF_CPT bit.

	Control Bit	Register Location	Description	Fund	ction
				0	1
ſ	IF_PD	R4[23]	IF Powerdown	IF PLL Active	IF PLL Powerdown

2.9 R5 REGISTER

The R5 Register contains the IF_TOC control word. The IF_TOC is used to setup the IF syhnthesizer's Fastlock circuitry. The IF_TOC is a 12-bit binary counter programmable from 0 to 4095.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	DATA[20:0] FIELD											ADDRESS [2:0] FIELD												
R5	0	0	0	0	0	0	0	0	0	IF_TOC[11:0]									1	0	1			

2.9.1 IF_TOC[0:11] - IF Synthesizer Timeout Counter (R5[14:3])

The OSCout/ FLoutIF pin can be configured as a general purpose CMOS TRI-STATE output or as a Fastlock output by programming the IF_TOC appropriately. When the IF_TOC is programmed from 0 to 3, Automatic Fastlock is disabled, and the OSCout/ FLoutIF pin is configured as a general purpose CMOS TRI-STATE output or Manual Fastlock is enabled. When the IF_TOC is programmed to 0, the OSCout/ FLoutIF pin will be in TRI-STATE (high impedance) mode. The charge pump current is then the value specified by IF_CPG (R3[19]). When the IF_TOC is programmed to 1, the OSCout/ FLoutIF pin is pulled to a LOW state. The charge pump current is then set to a HIGH gain state (IF_CPG bit = 1). This condition is known as the Manual Fastlock. When the IF_TOC is programmed to 2, the OSCout/ FLoutIF pin will again be pulled to a LOW state, but this time the charge pump current is the value specified by IF_CPG (R3[19]). When the IF_TOC is programmed to 3, the OSCout/ FLoutIF pin is pulled to a HIGH state. Again, the charge pump current is the value specified by IF_CPG (R3[19]). When the IF_TOC is programmed from 4 to 4095, Fastlock is enabled and the OSCout/ FLoutIF pin is pulled to a LOW state. Fastlock will time-out after the specified number of PFD events. At this time, the OSCout/ FLoutIF pin will switch to TRI-STATE (high impedance) mode. The value programmed into IF_TOC represents the number of PFD events that the IF synthesizer will spend in the Fastlock state. Note that any write to the IF_TOC requires a PFD event on the IF synthesizer to latch the contents. This means that writes to the IF_TOC take effect synchronously with the next PFD event.

IF_TOC[11:0]	FastLock Mode	Fastlock Period	OSCout/ FLoutIF Pin	I _{CPoutIF} Magnitude
		[PFD Events]	Functionality/ State	
0	Disabled	N/A	General Purpose.	I _{CPoutIF} magnitude
			High Impedance State	controlled by R3[19]
1	Enabled	N/A	General Purpose.	I _{CPoutIF} = 4 mA
	Manual Fastlock		Logic LOW State	
2	Disabled	N/A	General Purpose.	I _{CPoutIF} magnitude
			Logic LOW State	controlled by R3[19]
3	Disabled	N/A	General Purpose.	I _{CPoutIF} magnitude
			Logic HIGH State	controlled by R3[19]
4	Enabled	4	FastLock.	I _{CPoutIF} = 4 mA
	Automatic Fastlock		Logic LOW State.	Switches to 1 mA after
			Switches to High	4 PFD events
			Impedance after 4 PFD	
			events	
4095	Enabled	4095	FastLock.	I _{CPoutIF} = 4 mA
	Automatic Fastlock		Logic LOW State.	Switches to 1 mA after
			Switches to High	4095 PFD events
			Impedance after 4095	
			PFD events	

2.10 MUX[3:0] - MULTIFUNCTION OUTPUT SELECT (R3[23:22]:R0[23:22])

The MUX control word is used to determine which signal is routed to the Ftest/LD pin.

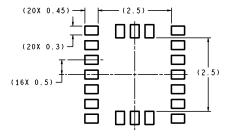
	MUX[3:0]		MUX Output State
0	0	0	0	High Impedance (TRI-STATE) State Output
0	0	0	1	Logic HIGH State Output
0	0	1	0	Logic LOW State Output
0	0	4	4	RF PLL and IF PLL Digital Lock Detect.
0	0	ı	I	Open Drain Output
0	1	0	0	RF PLL Digital Lock Detect.
0	'	U	0	Open Drain Output
0	1	0	4	IF PLL Digital Lock Detect.
0	'	U	I	Open Drain Output
0	1	4	0	RF PLL and IF PLL Analog Lock Detect.
0	'	ı	0	Open Drain Output
0	1	4	4	RF PLL Analog Lock Detect.
0	'	ı	ı	Open Drain Output
1	0	0	0	IF PLL Analog Lock Detect.
'	U	0	U	Open Drain Output
1	0	0	4	RF PLL and IF PLL Analog Lock Detect.
1	0	O	I	Push-Pull Output
1	0	1	0	RF PLL Analog Lock Detect.
1	0	ı	U	Push-Pull Output
1	0	1	1	IF PLL Analog Lock Detect.
1	0	ı	I	Push-Pull Output
1	1	0	0	IF_R/ 2 Frequency
1	1	0	1	IF_N/ 2 Frequency
1	1	1	0	RF_R/ 2 Frequency
1	1	1	1	RF_N/ 2 Frequency

Notes:

1. RF_N = (RF_B * RF_P) + RF_A

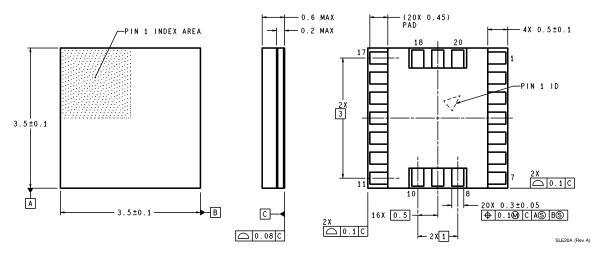
2. $IF_N = (IF_B * IF_P) + IF_A$

Physical Dimensions inches (millimeters) unless otherwise noted



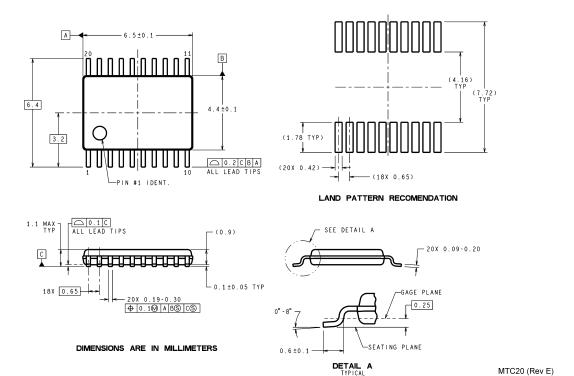
RECOMMENDED LAND PATTERN
1:1 RATIO WITH PACKAGE SOLDER PADS

DIMENSIONS ARE IN MILLIMETERS



20-Pin Ultra Thin Chip Scale Package (UTCSP) NS Package Number SLE20A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



20-Pin Thin Shrink Small Outine Package (TSSOP) NS Package Number MTC20

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